



## Test Report

Herschel

Title: Test Report for SPIRE FM SMEC Test  
@ He1 Conditions

CI-No: 125 200

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1	21.05.08	All	Formal Issue	

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## 1 Scope

This document reports on the SMEC (SPIRE Mechanism) Test performed on the SPIRE FM Instrument to check correct operation, after cool down of the HERSCHEL satellite to He1 temperatures. Additionally to the SMEC performance the impact of micro-vibration caused by the SVM reaction wheels on the SMEC was planned, however not performed.

The test was done with the S/C mounted on the MPT in horizontal position with +Y axis upwards. The test was executed using the Herschel CCS & I-EGSE.

### 1.1 Objective

The objectives of this reduced Cold CFT were:

- To check the correct functional operation of the SPIRE FM Mechanism under He1 conditions on nominal and redundant side
- To check the impact of micro-vibration caused by the SVM reaction wheels on the SMEC.

### 1.2 Test Flow

The SMEC test flow was structured to reflect nominal operations of SPIRE as much as possible to enable re-use higher-level Satellite tests.

The flow is as follows:

The SMEC Test flow is as follows:

1. Power on and configure SPIRE I-EGSE for test
2. Power on and configure SVM for test including CCU
3. Power on NOMINAL SPIRE Prime DPU & DRCU and enable Mil1553B-bus interface
4. Run SMEC CFT Nominal Procedures according to AD 1
5. Run SMEC Micro-vibration Procedures (on Nominal only) according to AD 1 (**not done**)
6. Power off MCU Prime
7. Disable Mil1553B-bus interface and Power off SPIRE Prime DRCU & DPU
8. Repeat Steps 3, 4, 6 & 7 for Spire Redundant SMEC CFT Procedures (**not done**)
9. Power off SVM including CCU
10. Switch off all EGSE

### 1.3 Procedure Execution Summary:

This test has been run with the HERSCHEL S/C in horizontal position (X - axis horizontal, +Y- axis upwards, precision  $\pm 0.5^\circ$ ) and on SPIRE nominal side only.

The cryo L1 temperature was around 8 K.

The test duration of the SPIRE SMEC Test was 7 hours 25 min.

The following protocols have been written documenting the SPIRE SMEC Test status:

TRR for SPIRE SMEC Test in 13.05.2008, HP-2-ASED-MN-1547  
He1

PTR for SPIRE SMEC Test in 16.05.2008, HP-2-ASED-MN-1552  
He1

Location: ESTEC, Noordwijk, NL

Test Case: S/C Reconfiguration

Test Session Name:

2008\_05\_16\_01\_30\_hercdmu\_hpws22\_REALTIME\_SC\_  
FDIR

Environment:

HP\_2\_ASED\_TP01920\_IST\_SC\_Reconfiguration\_BEGIN  
\_001

OBSW: CDMS 3.4.0.9, ACMS 3.7

HPADB: H-P-2-ASP-LI-1441 issue 10

HPCCS Release: Hpccs\_2.0-1219

Any procedure variations are recorded in the Procedure Variation Summary in § 7.1 for the corresponding “as-run” procedure.

All non-compliances are recorded in the Observation/NCR Summary below and detailed further in Section 3.

The following observations were made during the test:

Time (UTC)	Test Procedure / Step / Script / Command / Event / Anomaly	Remarks / Cause of anomaly / Corrective action	C/A type (T/P)	NCR ref. (P)
	New Constraints Sheet	OK		
	Skins verified and signed	OK		
01:00	Given Permission to start switch on and test			
01:40	START SWITCH ON using Leading Proc and configuring for SC Reconfiguration Test	FORMAL RUN for SC Reconfiguration		
02:45	Perform GYRO Calibration in parallel with switch on	ACS0282		
02:57	Wait 30 min for Gyro Warm up	Monitoring Raw Values of Parameters AEGRA002, B002, C002 & D002 – No Eng Values available?		
03:28	Wait 15 min to Record Gryo stability			
03:58	Gryo Completed	Ave worked out and found the following values: AEGRA002     -4.411769E-05 AEGRB002     -6.738856E-05 AEGRC002     -2.181644E-05 AEGRD002     1.939239E-06  file IST_FD_B.txt modified.		
04:44	SC switch ON completed	Ready to perform SC Reconfiguration		
04:45	Start Formal Run of SC Reconfiguration			
05:39	Problem: The point mode remains in coarse pointing when it should be in fine pointing. There is an oscillation around			
07:51	Starting SPIRE SMEC Test, Primary side			
08:15	SPIRE Switch ON, booting from 2 <sup>nd</sup> partition			
08:30	Power On stopped at SPIRE-IST-COLD-DPU-START-P-SP waiting for IEGSE packet, the received one was too old (9 sec difference)	Stop and restart IEGSE connection with NTP update		
	Switch OFF SPIRE, terminate SPIRE-IST-COLD-DPU-START-P-SP			
	Terminate S102999SCVT031_ASDCFTSPIR_PWR_ON_P			
08:38	Send cmd DC11B170 to open LCL11			
08:47	Restart SPIRE PWR ON acc. to chapt. 7.2.6.1 step 12ff			

Time (UTC)	Test Procedure / Step / Script / Command / Event / Anomaly	Remarks / Cause of anomaly / Corrective action	C/A type (T/P)	NCR ref. (P)
08:50	terminate SPIRE-IST-COLD-DPU-START-P-SP again	Time sync not done on CCS handler		
08:51	Restart SPIRE-IST-COLD-DPU-START-P-SP			
09:00	SPIRE Powered ON at 09:00			
10:02	Set SMEC motor current to zero, PVS6 Current before ca. -90mA, after 0.0mA	Unwanted heating effect while investigating LL status		
	Latch Status EGSE installed on CB 312300 P01			
10:30	Green LED is on => Mechanism is "Latched"			
11:53	Execution of PVS#7 step 0			
11:56	From yesterday debug we found that OBDB parameter H_NOM_AUX_R_UNLOAD_TORQUE value is not correctly set.	Corrected wheel profile sequence for the SPIRE micro-vibration test with correct OBDB parameter H_NOM_AUX_R_UNLOAD_TORQUE value from -0.02 to -0.05Nm.		SPR 533
12:29	Execution of PVS steps 1 to 7			
	Step 6 value of WM107565 is still zero (expected 180 mA)			
12:40	Execute step 7 of PVS#7: send HL cmd#5, current is 180 mA			
12:40	Execute step 7 of PVS#7: send HL cmd#6, current is 0 mA			
12:42	Execute step 8 of PVS#7: Switch OFF LCL#25			
12:45	Execute step 9 of PVS#7			
12:57	Execute PVS#6 step3 to manually unlatch the lock, EGSE still "green"			
13:08	Continue with chapter 7.2.6.7 of TP			
13:13	Send cmd of PVS#6 step1, no indication of LL is unlatched			
14:01	ExecutePVS#8 step1, LL EGSE light is still "green"			
14:03	ExecutePVS#8 step2, LL EGSE light is still "green"			
14:04	ExecutePVS#8 step4			
14:09	ExecutePVS#8 step5			
	ExecutePVS#8 steps 6,7,8, 9			
15:20	Execute PVS#9	The SMEC mechanism seems not to unlock; NCR to be raised		NCR-4221
15:27	Execute PVS#9 step 2			
15:30	Execute PVS#9 step 3			
15:53	Execute PVS#9 steps 4, 5, 6			
15:55	Execute PVS#9 step 7			
16:03	Execute PVS#9 step 8			
16:05	Execute PVS#9 step 9			

Time (UTC)	Test Procedure / Step / Script / Command / Event / Anomaly	Remarks / Cause of anomaly / Corrective action	C/A type (T/P)	NCR ref. (P)
16:17	Execute PVS#9 step 10			
16:18	Execute PVS#9 step 11			
16:26	Execute PVS#9 step 12			
16:30	Execute PVS#9 step 13			
16:34	Execute PVS#9 step 14			
16:45	Execute PVS#9 step 15			
16:48	Execute PVS#9 step 16	SMEC mechanism stiction behaviour observed==> raise new NCR		NCR-4222
17:52	Execute PVS#10 step 1			
17:54	Execute PVS#10 step 2 with manual cmds			
18:42	Perform PVS 10 Step 3			
18:46	Perform PVS 10 Step 3.1			
	Perform PVS 10 Step 3.2a ==> failed.			
19:00	Performed manual cmds acc PVS#11			
19:14	Latch Lock Confirmed	...but could also be "locked" by the friction..... To verify locking, manual cmd is sent to apply current to the SMEC to see if it moves. IF not moving then positively locked !! Then reduce current to 0 again. Covered by PVS#11.2 Result: Launch Lock confirmed by PI-SPIRE to be locked.		
19:21	Switch-off SMEC			
19:22	Switch-off MCU			
19:24	Switch-off SCU			
21:17	Starting to Switch off S/C			
22:50	S/C is OFF			

Table 1: SPIRE SMEC Test Summary

## 2 Documents/Drawings

### 2.1 Applicable Documents

AD1 IST INSTRUMENT COMMISSIONING  
SPIRE FM COLD FUNCTIONAL TEST

HP-2-ASED-TP-0217,  
Issue 1

### 2.2 Reference Documents

None

### 2.3 Other Documents

None

### 2.4 Acronyms & Abbreviations

See "as-run" procedure.

### 3 Main Observations and Problems Identified.

Three NCR's have been raised following this run of the SPIRE SMEC Test and two can be closed.

#### 3.1 SPIRE Launch Lock does not open during SMEC test on nominal side (NCR-4221)

The test has been executed until the step where the mechanism was unlocked. The unlocking, however, was not properly executed.

Further test result analysis showed that after the LPU test the mechanism was moving and the test could be continued.

For further use of the mechanism the procedures will be updated to include HL commands to be sure on the latch position.

#### 3.2 SMEC Mechanism friction behaviour in start region (NCR-4222)

After performing the open loop scan, the SPIRE TM showed a non-symmetrical pulse, indicating a possible friction problem at the mechanical end stop. The sticking region is in the order of about 2 mm outside the optical range.

Therefore, a repetition of the test in advance to S/C vibration testing is not required.

#### 3.3 Launch Lock EGSE not properly functioning (NCR-4223)

The test has been executed until the step where the mechanism was unlocked. The unlocking, however, was not properly executed. Therefore, a small EGSE box with two LED's, indicating the Latch status, was implemented at CB312300 and connected to P01. The LED indication was always "green" which is equivalent to the "locked" status, even when the Latch status was unlocked.

This has been caused by the fact that the connector P02 was still in place which needs to be removed for proper functioning of the box.

The procedure for the integration of the SPIRE LL EGSE (ref. HP-2-ASED-SD-0278) will be updated.

#### 3.4 SPIRE LPU wrong parameters for LCL in HPSDB (NCR-4000)

The LPU test was performed and NCR can be closed

### 3.5 Instrument Merged MIB failed to be loaded (NCR-4001)

SPIRE Merged MIB could be loaded on I-EGSE and worked properly with CCU, NCR can be closed for SPIRE

### 3.6 Procedure Changes

Updates and clarifications in the CFT procedure as required during the test execution were included by redlining. All necessary modification have been reported in chapter 8.1, "Procedure Variation Summary".



## 4 Conclusion

The SPIRE SMEC Test under He1 conditions was only performed on the nominal side. The micro-vibration test and SMEC test on the redundant side have not been performed due to the sticking problem near the mechanical end stop of the mechanism as reported by NCR-4222.

The detailed evaluation of the test results has been performed by RAL.

The Non-Conformance Reports (listed above) as raised during the test affected the test objectives.

Even though this test was not successfully executed, it has been decided during the NRB of the before mentioned NCR's that the test will not be repeated before S/C vibration testing.

### 4.1 Open Issues

- Redundant SMEC test
- Micro-vibration test

### 4.2 Requirements Verified

With the above test the requirement for the SPIRE CFT incl. SMEC test, according to chapter 4.7.3 of "Test Specification for HERSCHEL Instruments FM tests performed at satellite level", ref. H-P-2-ASP-TS-1083, should have been verified for the outstanding parts.

## 5 Appendix 1: SPIRE SMEC Test As-Run Procedure

(ref. HP-2-ASED-TP-0217, issue 1)

AS RUN Copy FOR SMEC TESTING ONLY  
160508 NOT CFT.  
sessionid=2008-05-16-01.30-hercdmu-hpws22-REALTIME-SC-FDIR

Title: **IST Instrument Commissioning  
SPIRE FM Cold Functional Test**

CI-No: 125200

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TASF approval	D. Mantel		
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## 1 Scope

This document describes the set of Cold Functional Tests (CFTs) to be performed on the SPIRE FM Instrument for IST Instrument Commissioning (ref AD6 & AD9) in Hell conditions.

It also includes the SMEC Functional & Microvibration Tests. However, these have to be run independently of the other parts of the CFT, as they require a very specific test and satellite configuration.

Both redundancies are tested within this procedure.

### Constraints General

- This procedure requires the presence of SPIRE personnel as the I-EGSE will be required to assess the results online as part of the pass/fail criteria.
- Before carrying out the next procedure within the test sequence always ask for the go ahead by the SPIRE staff.

### Constraints Specific

- The **CFT** part of the procedure **shall** only be performed in Hell conditions
- The **SMEC** part of the procedure **shall** only be performed in Hel conditions, with satellite Horizontal and Cryostat fill level **at 50%**. *< 50%*
- **SMEC** Microvibration tests shall be performed with minimal external acoustic noise/vibration (e.g. at night)
- For **SMEC** Microvibration tests the following **Cryo temperatures shall be maintained:** *functional in He I*
  - Level 0 temperature: <10 K no drift constraint
  - Level 1 temperature: < 10 K no drift constraint
  - Level 2 temperature: < 15 K no drift constraint*a L1 temperature between 10K and 20K with a stability of ~ 2K is tolerable, since the encoder is less sensitive as it gets warmer. For L0 and L2 section 5.2 applies.*

#### 1.1 Objective

The objective of the test is to functionally check FM instrument as much as feasibly possible in Hel or Hell conditions in an AIT environment.

#### 1.2 Test Flow

The CFT flow is as follows:

1. Power on and configure SPIRE I-EGSE for test
2. Power on and configure SVM for test including CCU

3. Power on NOMINAL SPIRE Prime DPU & DRCU and enable Mil1553B-bus interface
4. Run Nominal CFT Procedures
5. Power off MCU Prime
6. Disable Mil1553B-bus interface and Power off SPIRE Prime DRCU & DPU
7. Repeat Steps 3 – 6 for Spire Redundant CFT Procedures
8. Power off SVM including CCU
9. Switch off all EGSE

The SMEC flow is as follows:

1. Power on and configure SPIRE I-EGSE for test
2. Power on and configure SVM for test including CCU
3. Power on NOMINAL SPIRE Prime DPU & DRCU and enable Mil1553B-bus interface
4. Run SMEC CFT Nominal Procedures
5. Run SMEC Microvibration Procedures (on Nominal only)
6. Power off MCU Prime
7. Disable Mil1553B-bus interface and Power off SPIRE Prime DRCU & DPU
8. Repeat Steps 3, 4, 6 & 7 for Spire Redundant SMEC CFT Procedures
9. Power off SVM including CCU
10. Switch off all EGSE

## 2 Documents/Drawings

### 2.1 Applicable Documents

AD 1	FM SPIRE PFM Final Electrical Integration Procedure	HP-2-ASED-TP-0166
AD 2	Herschel PCDU & CDMS Nominal Switch On/Off Procedure	HP-2-ASED-PR-0070
AD 3	Herschel SAT Emergency Switch Off Procedure	HP-2-ASED-PR-0071
AD 4	PA Plan	HP-2-ASED-PL-0007
AD 5	I-EGSE Switch ON/OFF Procedure	TBI
AD 6	Test Specification for Herschel Instrument AVM & FM Tests Performed at Satellite Level, Issue 2	H-P-2-ASP-TS-1083
AD 7	H-P GDIR	H-P-1-ASPI-SP-0027
AD 8	SPIRE I-EGSE Set-Up, Issue 2.1	SPIRE-RAL-DOC-002841
AD 9	Herschel Integrated Satellite Test Specification, Issue 5	H-P-2-ASP-SP-0939
AD 10	Herschel IST Lead Procedure	HP-2-ASED-TP-0134

### 2.2 Reference Documents

RD 1	Herschel Planck Central Checkout System System User Manual	H-P-4-TE-MA-0010
RD 2	SPIRE Cold Functional Test Procedures, Iss. 2.4	SPIRE-RAL-PRC-2398
RD 3	Herschel CDMU ASW S/W Interface Control Document	H-P-4-SSF-IC-0001
RD 4	Herschel CDMU BSW S/W Interface Control Document	H-P-4-SES-NT-0076
RD 5	SPIRE IID-B	SCI-PT-IIDB/SPIRE-02124

RD 6	SPIRE Functional Test Specification Iss. 1.4	SPIRE-RAL-DOC-001652
RD 7	SPIRE Instrument User Manual Iss. 1.0	SPIRE-RAL-PRJ-002395
RD 8	H/P OBT-UTC Time Synchronisation Technical Note Iss. 1.3	PT-CMOC-OPS-TN-6604-OPS- OGH
RD 9	SPIRE IST SPT Procedure; Iss 3.1	SPIRE-RAL-PRC-2398

**2.3 Other Documents**

None

**2.4 Acronyms & Abbreviations**

1553	MIL-STD-1553B conform communication interface
AAD	Attitude Anomaly Detector
ACC	ACMS Control Computer
ACMS	Attitude Control and Measurement Subsystem
AD	Applicable Document
AIR	ACC In Reconfiguration
AIT	Assembly, Integration and Test
AIV	Assembly, Integration and Verification
APID	Application Process ID
ASW	Application Software
AVM	Avionics Model
BOLC	BOLometer Control unit (PACS)
BSW	Basic Software
CBH	Catalyst Bed Heater
CCS	Central Check-out System
CCSDS	Consultative Committee for Space Data Systems
CDMU	Control and Data Management Unit
CDMS	Control and Data Management Sub-system
CFT	Cold Functional Test
CIR	CDMU In Reconfiguration
CLCW	Command Link Control Word

CLTU	Command Link Transmission Unit
CPDU	Command Pulse Distribution Unit
CRS	Coarse Rate Sensor
CTR	Central on board Reference Time
<hr/>	
DCU	Detector Control Unit (SPIRE)
DEC	Detectors Electronics Control unit (PACS)
DMC	Detector and Mechanism Control unit (PACS)
DPU	Digital Processing Unit
DRCU	Detector Readout & Control Unit (SPIRE)
EEPROM	Electrically Erasable PROM
EGSE	Electrical Ground Support Equipment
FCL	Fold-back Current Limiter
FCU	FPU Control Unit (Spire)
FCV	Flow Control Valves
FDIR	Failure Detection, Isolation, and Recovery
FPU	Focal Plane Unit
GDIR	General Design and Interface Requirement
GRP	Group Heaters Switch
HBR	High Bit Rate
HL/HLC	High Level command
HP/HPC	High Priority commands
HPLM	Herschel PayLoad Module
HPsDB	Herschel Planck System Data Base
HW	Hardware
i.a.w.	In accordance with
I/F	InterFace
I/O	Input/Output
ICD	Interface Control Document
IST	Integrated System Test
LCL	Latching Current Limiter
LV	Latching Valves
LBR	Low Bit Rate



MAP	Multiplexed Access Point
MBR	Medium Bit Rate
MCU	Mechanisms Control Unit (SPIRE)
MEC	Mechanisms Electronics Control unit (PACS)
<hr/>	
ML 16	Memory Load command (ML 16)
MM	Memory Module
MOIS	Mission Operations Information System
MTL	Mission Timeline
NRZ-L	Non Return to Zero – Litton
OBCP	On-Board Control Procedure
OBDH	On-Board Data Handling
OBMF	On-Board Monitoring Function
OBRT/OBT	On-Board Reference Time
OIRD	Operation Interface Requirement Document
PACS	Photodetector Array Camera & Spectrometer
P/L	Payload
PCDU/PCS	Power Control Distribution Unit/Power Control Subsystem
PM	Processor Module
PROM	Programmable Read Only Memory
PSK	Phase Shift Keying
RA	Rate Anomaly
RAM	Random Access Memory
RCS	Reaction Control Subsystem
RD	Reference Document
RF	Radio Frequency
RM	Reconfiguration Module
RT	1553 Remote Terminal
RTU	RT Unit
RTA	RTU
RWL	Reaction Wheel Assembly
SA	1553 Remote Terminal Sub Address
SAS	Sun Acquisition Sensor

SCOE	Special Check-out Equipment
SCU	Subsystems Control Unit (SPIRE)
SIR	S/C In Reconfiguration
SIT	Subsystem Integrated Test
SP	Sun Pointing
SPIRE	Spectral & Photometric Imaging Receiver
SPU	Signal Processing Unit (PACS)
SSMM	Solid State Mass Memory
STR	Star Tracker
SVM	Service Module
SW	Software
TAI	International Atomic Time
TC	TeleCommand
TFG	Transfer Frame Generator
TM	TeleMetry
TTC	Telemetry Tracking & Command subsystem
TTR	Telemetry Telecommand and Reconfiguration
UFT	Unit Functional Test
VC	Virtual Channel
WD	Watchdog

### 3 Configuration

#### 3.1 Satellite Configuration

The test requires use of the FM SVM powered on in its basic test mode (i.e. quick switch on (PCDU & CDMS) in accordance with AD 2 plus CCU connected to cryostat temperature and pressure sensors. Note this also means that the cryostat valves (commandable from the CCS) may also be connected therefore this has to be considered as a SAFETY critical area to be addressed in section 5.

SPIRE FM units will be powered ON as per this procedure and assumes that FPU has already been successfully integrated to the warm units. *(+Y axis up)*

The Cryostat and therefore the satellite must be horizontal to perform the SMEC parts (section 7.2.4) of the CFT.

#### 3.2 EGSE Configuration

This test requires the EGSE to be configured and elements powered on in accordance with AD 2.

I-EGSE shall be configured and connected to the HPCCS in accordance with AD 5 & AD 8.

#### 3.3 Set-up

SPIRE Test Scripts for the test must be loaded on to the HPCCS and checked in prior to start of test.

## 4 Test Sequence

Ensure that the latest delivery of SPIRE CFT & SPT test scripts are installed on the CCS prior to start of test.

---

The SPIRE I-EGSE will be running the following software for the test:

I-EGSE Software	Version	Comment
SPIRE MIB version	1424 Iss 4	Merged MIB
SPIRE CUS version	1430	
SCOS version	2.3EP5	

The HPCSS HPSDB must also include the same SPIRE MIB version.

**5 Conditions**

**5.1 Personnel**

Responsibility	Name / Organisation
Test Director	B. COLLAUDIN / TAS-F
Test Conductor	A. KOPPE / ASED
EGSE Operator	S. HARTER / ASED
PA Responsible	D. HENDRY / ASED
Instrument Representative	S. SIDNER / RA
Customer Representative	B. COLLAUDIN / TAS-F
ESA Representative	

**5.2 Environmental**

The actual clean room and spacecraft environmental conditions for the test shall be recorded below.

Clean Room Conditions	Nominal	Actual
Clean Room Class	class 100000 or better	✓
Temperature	22°C ± 3°C	✓
Rel. Humidity	40 % - 60 %	✓
Pressure	Ambient	✓

S/C Environmental	Required	Actual
S/C Orientation	CFT: 20° from Z, +Y down SHEC: horizontal, +Y up	horizontal, +Y up
Cryostat Status (Hel/Hell)	CFT: He II SHEC: He I <del>He II</del>	He I
Cryostat Level 0 Temp	CFT: T < 2.0 K SHEC: 4.2 K < T < 6.5 K	4.7 K <del>5.25 K &lt; T &lt; 7.3 K</del>
Cryostat Level 1 Temp	CFT: T < 6.2 K SHEC: 10 K < T < 20 K **	<del>5.25 K &lt; T &lt; 7.3 K</del>
Cryostat Level 2 Temp	CFT: T < 12 K SHEC: 5 K < T < 30 K	17 K
Cryostat Level 3 Temp	CFT: 10 < T < 15 K SHEC: N/A	N/A

15/05/08  
S

T235 = 8.1 K  
T236 = 8.7 K

\* for JFET switch ON only      \*\* stability of 2 K/°C (HP-2-ASED-MN-1528) test period 10.04.08

**5.3 General Precautions and Safety**

Non-test specific precautions and safety considerations are detailed in section 5.3 of AD 2. Specific safety issues and general precautions for the tests to be performed are detailed in the following sections.

**5.3.1 General Safety Requirements, Precautions**

In the event of unrecoverable anomaly requiring emergency switch off of the satellite, the switch off shall be performed in accordance with AD 3.

**5.3.2 ESD constraints**

Normal ESD constraints are to be observed during the test.

**5.3.3 Cryo Specific Safety Requirements**

During the test the CCU may be connected to the Cryostat sensors and valves. Although no valve operation is performed in this test all Cryogenic specific safety requirements shall be considered when running this procedure as indicated below.

Safety instruction for cryogenic hazards coming from the Helium system are as follows:

1	Helium itself is a non-toxic gas. The hazards to be expected are personal injuries from frostbites (cold surfaces, cold gas plumes), asphyxiation due to insufficient oxygen in the remaining air, loss of orientation due to dense fog generation and impacts of cold damaged structures.
2	<p>Due to the amount of stored energy the Herschel cryostat is a pressure vessel and the general rules for pressure vessel design have to be followed. In addition to these general rules, the safety regulations at CSG launch site have to be considered. The application of these rules leads to a safety concept, which is based on the 'leak before burst' criterion. Herschel is based on the following safety and reliability philosophy:</p> <ul style="list-style-type: none"> <li>a. Two failure tolerant</li> <li>b. Three independent paths for overpressure relief</li> <li>c. Passive safety system for all operation modes (no active controls for monitoring is required at any time)</li> </ul> <p>As emergency situations may occur at unexpected points in time and typically need immediate action, the full hierarchy of the project cannot be deployed and consultation of all knowledgeable persons may not be possible.</p>
3	<p>The main intent of immediate actions will therefore be to ensure safety of personnel and to bring the S/C into a safe waiting condition. The priority of safeguarding is</p> <ul style="list-style-type: none"> <li>1) Personnel</li> <li>2) S/C</li> <li>3) Facility</li> <li>4) Support equipment</li> </ul> <p>The second aim is to keep the cryostat near the foreseen test conditions in order to continue the test without unnecessary time delay if the failure can be corrected.</p>
4	The ASED test director (or his representative) will be informed by the test personnel of any non-conformances, alarm and unforeseen events that might lead to emergency situations. The ASED test director (or his representative) will initiate immediate steps and call the decision committee (ASED test director, ASED PA, ESA test director, ASP representative, ETS representative) if necessary.



5	Prior to begin a pre-task briefing shall be performed to inform all participants about purpose of operation, possible hazards and emergency shut down
6	<p>In case of operation of the Cryostat safety system the following IMMEDIATE activities shall be performed:</p> <ul style="list-style-type: none"> <li>• Operation of the safety valve: EVERYBODY has to leave the test room, <u>except</u> test Conductor and necessary CVSE operations personnel</li> <li>• Operation of burst disc: EVERYBODY has to leave the test room</li> </ul>

**5.3.4 Special QA Requirements**

None.

**5.4 GSE**

Non-test specific GSE details are provided in section 5.4 of AD 2. Specific GSE needs for the tests to performed are detailed in the following sections.

**5.4.1 MGSE**

None.

**5.4.2 CVSE**

None.

**5.4.3 EGSE**

The I-EGSE is required for this test and will be connected to the HPCCS in accordance with AD 5.

**5.4.4 OGSE**

None.

**5.4.5 Special Equipment**

None.

## 6 Verification Requirements and Test Criteria

This is a functional check of all SPIRE PFM subsystems in Hel or Hell conditions and AIT configuration as per AD6 and AD9.

Functional performance and status parameter actual values recorded will be checked during the test and must be the same as the nominal status value indicated.

The test will only be deemed successful once all offline analysis of the results has been performed. Typically, the PTR will be held before completion of this activity and therefore only a preliminary assessment of the test success can be provided to allow disconnection of any specific GSE required for the test and which needs to be removed before further activities can be performed.

Enter Start Date/Time:			
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**7 Test Procedure**

**7.1 Initial EGSE and Satellite Configuration for the Test**

The Spire FM Final Integration according to the Test Procedure ref. AD 1 must be successfully completed before the execution of this procedure.

The EGSE and Satellite must be configured according to AD 2 prior to start of test.

*In case of anomaly on SPIRE requiring immediate switch off as directed by SPIRE responsible supporting the test section 7.2.8 shall be executed.*

*In the event of emergency the Satellite SHALL be switched down according to AD 3.*

<b>Enter Date/Time:</b>			<b>Sign Off:</b>
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Doc. No: HP-2-ASED-TP-0217

Issue: 1

Date: 08.05.08

File: SPIRE FM IST Inst Comm CFT TP HP-2-ASED-TP-0217 Iss1.doc

Enter Start Date/Time:	
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7.2 Step by Step Procedure

Test Location:	
Test Session Id:	2008-05-16-01-30-hereduu_hpus 22-learnme_sc-ADR.
Test Environment:	HP-2-ASED-TP01920-1ST-SC-RECONFIGURATION-BEGIN-001

7.2.1 EGSE & Satellite Switch On for CFT

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
	<b>Satellite &amp; EGSE Switch On</b>						
1	Confirm I-EGSE physically connected to HPCCS	OK					
2	Switch on & configure SPIRE I-EGSE i.a.w. AD5 & AD 8	OK					
3	Confirm SPIRE I-EGSE is in the correct configuration as per AD5 & AD 8	OK					
4	Switch on HPCCS, SCOEs and Satellite/SVM i.a.w. AD 10 section TBD (1ST START for SPIRE Commissioning)	OK					
5	Confirm that EGSE and Satellite are in the correct configuration as per AD 2	OK					
6	If not already on, from HPCCS power ON CCU A & CCU B by						

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:									
Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N		
	executing test script: <b>K102999ECVT001_ASDGENCCU_ABPWON</b>	OK							
7	If not already enabled, from HPCCS enable Monitoring Mode 1 (512sec cycle) for CCU A & B by executing test script:								
8	<b>K102999ECVT001_ASDGENCCU_MinEBOTH1</b> From HPCCS Test Conductor console issue command to connect to SPIRE I-EGSE <b>connect HSPIREEGSE</b>	OK							
9	Confirm from HPCCS and SPIRE I-EGSE that the connection has been established <b>connect HSPIREEGSE</b>	YZS29940= CONNECTED			AND SYS_PARS				
10	Verify that I-EGSE is receiving CCU Cryo packets	OK							
11	On HPCCS start the following test script: <b>ALL_SubscribeParams.tcl</b>	OK							
12	Verify HPCCS-I-EGSE connection by sending test command: <b>YC00X066</b> From the manual command stack (repeater value of "0")	OK							
13	If required load Synoptics INSTRUMENTS on HPCCS to display SPIRE status overview <b>READY FOR START OF SPIRE CFT</b>								

<b>Enter Date/Time:</b>	<b>Sign Off:</b>
Doc. No: HP-2-ASED-TP-0217	
Issue: 1	
Date: 08.05.08	

Enter Start Date/Time:	
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**7.2.2 Cold Functional Tests - Nominal**

**7.2.2.1 Switch ON SPIRE PRIME**

The following will switch ON and configure SPIRE Prime instrument in REDY (Standby) mode. HKTM packets will be generated on APIDs 1280 dec and 1282 decimal (these can be observed using TMPH with corresponding filter – note however a limited number of TMPHs should be running at one time).

During power on of SPIRE a number of soft/hard OOLs are reported due to the sequential switch on of the units. This is expected and will clear when SPIRE is in REDY mode. When in REDY mode one parameter remains OOL (soft) namely SMD2V505 this is also expected.

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
1.	On HPCCS start Packet History displays for the following APIDs:1280,1282	OK				
2.	From the HPCCS test conductor console start the test script to power on SPIRE Prime: S102999SCVT031_ASDCFTSPIR_PWR_ON_P	OK		AND: ZAD07999, ZAD14999 MIM: LCL_HERSCHEL		

Enter Date/Time:		Sign Off:	
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Enter Start Date | Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
3.	<p>On HPCCS when prompted:</p> <p>"SPIRE Switch ON for Cold FT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct"</p> <p><b>Select YES</b></p>	YES				
	<p>If <b>YES</b> is selected the test script will go on to automatically power on all SPIRE warm units, force boot the DPU ASW and configure the instrument to Standby mode. Reply to prompts as indicated below.</p>	2/14				
4.	<p>On HPCCS when prompted:</p> <p>"Check Telemetry Updating Correctly and OBT is Consistent with CDMU - OK to continue"</p> <p><b>Select OK</b></p>	OK		AND: SA_1_559		

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Doc. No: HP-2-ASED-TP-0217  
 Issue: 1  
 Date: 08.05.08

Enter Start Date/Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
5.	<p>If I-EGSE connected when prompted on HPCCS, perform check requested then select OK:</p> <p>"Check IEGSE Time Consistent - OK to continue when RAL confirm"</p>	OK				
6.	<p>On HPCCS when prompted:</p> <p>"Check Telemetry No Longer Updating - OK to continue"</p> <p>Check that parameters:</p> <p>THSK Not refreshing            TM2N Not incrementing            OK</p> <p>Select OK to continue</p>					
7.	<p>On HPCCS when prompted:</p> <p>"Check Telemetry Updating Correctly - OK to continue"</p> <p>Check that parameters:</p> <p>THSK Refreshing @ 1Hz            TM2N Incrementing by 1 @ 1Hz            OK</p> <p>Select OK to continue</p>			AND: SA_1_559		

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_



Enter Start Date	Time:
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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
8.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT031_ASDCFTSPIR_PWR_ON_P it will prompt: "Set Bus Profile Back to Original Setting?" Select NO	NO				
9.	At the prompt: "Bus Profile left unchanged" Select OK to continue	OK				
10.	Verify HK TM packets are being received on APIDs 1280 & 1282	OK				
	<b>SPIRE DPU &amp; DRCU powered</b>					

Enter Date/Time:	Sign Off:
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Enter Start Date Time:	
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7.2.2.2 Procedure SPIRE-IST-COLD-FUNC-SCU-02-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCU Nominal Science Contents Check PRIME
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are switched ON, SPIRE_HK is being produced
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE-IST-COLD-DPU-ON-P and SPIRE-IST-COLD-DRCU-ON-P procedures have been executed.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• I-EGSE is up and running</li> <li>• DPU AND OBS PARAMETERS &amp; FUNCTIONAL TEST PARAMETERS displays are selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK parameters have the expected values <span style="font-size: 2em; vertical-align: middle;">2</span>

Procedure Steps:

Step	Description	Parameter	Expected Values Before/After	Actual Values Before /After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-02-P.tcl	SCUFRAMECNT TM5N	0/31 0x3FFF/1		
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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7.2.2.5 Procedure SPIRE-IST-COLD-FUNC-SCU-07-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Sorption Cooler Heater Check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Constraints</b>	<b>This test should not be performed at He II temperatures, unless specifically instructed to do so by the I-EGSE staff.</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail Criteria</b>	Sorption cooler heat switches and pump heater show expected voltages

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-07-P.tcl	—	—	—	
2	Wait for the parameter BBFULLTYPE to get set to Cooler_Htr_Chk	BBFULLTYPE	Cooler_Htr_Chk		

Enter Date/Time:		Sign Off:	
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Enter Start Date|Time: \_\_\_\_\_

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
3	Record the value of parameter SPHSV – the Sorption Pump Heat Switch Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	SPHSV – mV	0/~323/0		
4	Record the value of parameter EVHSV – the Evaporator Heat Switch Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	EVHSV – mV	0/~323/0		
5	Record the value of parameter SPHTRV – the Sorption Pump Heater Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	SPHTRV – V	0/~8.8/0		
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date Time:	
------------------------	--

7.2.2.6 Procedure SPIRE-IST-COLD-FUNC-PCAL-01-P

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	PCAL Characterisation Check (PRIME)
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	Unchanged
<b>Constraints</b>	<b>This test should only be performed at He I or He II temperatures</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail Criteria</b>	PCAL voltage and current agree with expected values

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Procedure Steps:

Step	Description	Parameter Name – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-PCAL-01-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Final Configuration: Unchanged

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7.2.2.7 Procedure SPIRE-IST-COLD-FUNC-SCAL-01-P

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCAL Characterisation Check (PRIME)
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	Unchanged
<b>Constraints</b>	<b>This test should only be performed at He I or He II temperatures. If the test is to be performed at He II temperature then please confirm with I-EGSE staff first.</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	18 minutes
<b>Pass/Fail criteria</b>	SCAL2 and SCAL4 voltage and currents agree with expected values

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCAL-01-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.8 Procedure SPIRE-IST-COLD-FUNC-MCU-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU (PRIME) Boot Check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCU voltages and board temperatures show expected 'ON' values

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Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-01-P.tcl	—	—	—	
2	Check that the MCU is booted up successfully	MCUBITSTAT	0/1/1		
3	Check MCU HK parameter values and ensure that the values are refreshing	MCUP5V MCUP14V MCUM14V MCUR15V MCUM15V MCUMACTEMP MCUSMECTEMP MCUBSMTTEMP	~ 5.0 ± 0.2V ~ 14.0 ± 0.5V ~ -14.0 ± 0.5V ~ 15.0 ± 0.5V ~ -15.0 ± 0.5V ~300K ~300K ~300K		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.9 Procedure SPIRE-IST-COLD-FUNC-MCU-03-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU Nominal Science Contents Check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	Unchanged.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK parameters show expected increment

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-03-P.tcl	MCUFRAMECNT	0/-/297		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.10 Procedure SPIRE-IST-COLD-FUNC-BSM-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (PRIME) Chop/Jiggle Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters CHOPSENSPWR and JIGGSENSPWR show expected ON values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-01-P.tcl	—	—	—	
2	Check that the Chop and Jiggle sensors have switched on	CHOPSENSPWR JIGGSENSPWR	0/1/1 0/1/1		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.11 Procedure SPIRE-IST-COLD-FUNC-BSM-03-P

Version	2.4
Date	6th December 2007
Purpose	BSM (PRIME) Open Loop Dynamics Check.
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	CHOPSENSIG/JIGGSENSIG HK parameter evolve in the same direction as the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-03-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.12 Procedure SPIRE-IST-COLD-FUNC-BSM-05A-P

Version	2.4
Date	6th December 2007
Purpose	BSM (PRIME) Open Loop Chop Test
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	The BSM Chops between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-05A-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.13 Procedure SPIRE-IST-COLD-FUNC-BSM-05B-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (PRIME) Close Loop Chop Test
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON.
<b>Final configuration</b>	BSM is in closed loop mode
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• CHOP PARAMETERS and JIGGLE PARAMETERS displays are selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	The BSM Chops in between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-INIT-P.tcl	CHOPLOOPMODE	3/-/1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-05B-P.tcl	JIGGLOOPMODE	3/-/1		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.14 Procedure SPIRE-IST-COLD-FUNC-BSM-06-P

Version	2.4
Date	6th December 2007
Purpose	BSM (PRIME) Closed Loop Operational Mode Chop Test
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE/HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON. BSM is in closed loop.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• CHOP PARAMETERS and JIGGLE PARAMETERS displays are selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	The BSM Chops between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-06-P.tcl	CHOPLOOPMODE JIGGLOOPMODE	1/1/1 1/1/1		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.15 Procedure SPIRE-IST-COLD-BSM-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (PRIME) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. BSM Chop/Jiggle sensors are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters CHOPSENSPWR and JIGGSENSPWR show expected OFF values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-OFF-P.tcl	—	—	—	
2	Check that the power to the BSM sensors is switched off	CHOPSENSPWR JIGGSENSPWR	1/-/0 1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.16 Procedure SPIRE-IST-COLD-FUNC-SMEC-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Encoder/LVDT Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENCPCR and SMECLVDTPWR show expected ON values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-01-P.tcl	—	—	—	
2	Check that power to the SMEC LED and LVDT sensor is on	SMECENCPCR SMECLVDTPWR	0/-/1 0/-/1		
<b>Test Result (Pass/Fail):</b>					

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**7.2.2.17 Procedure SPIRE-IST-COLD-FUNC-SMEC-03-P**

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Encoder Integrity Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCUENGSMECENCISIG1/2 increase as the encoder power is increased

**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-03-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.18 Procedure SPIRE-IST-COLD-SMEC-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENC PWR and SMECLVDT PWR show expected OFF values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-SMEC-OFF-P.tcl	—	—	—	
2	Check that the power to the SMEC sensors is switched off	SMECENC PWR SMECLVDT PWR	1/-/0 1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.19 Procedure SPIRE-IST-COLD-FUNC-DCU-02-P

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
	<b>Cryostat Check Procedure for CFT</b>						
2	Prior to performing next step verify that Level 3 temperature is between 10K and 15K (sensors T246 & T247)	OK					
3	Record Temperatures: T246: (KD223302 if connected to CCU) >10K - <15K T247: (KD223303 if connected to CCU) >10K - <15K						
	<b>End of Cryostat Check</b>						

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	DCU Nominal Science Contents Check PRIME
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are switched ON, SPIRE HK is being produced and MCU is booted.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE-IST-COLD-DPU-ON-P and SPIRE-IST-COLD-DRCU-ON-P procedures have been executed.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• I-EGSE is up and running</li> <li>• DCU PARAMETERS display is selected on the CCS</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters increment as expected

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Procedure Steps:

Step	Description	Parameter	Expected Values Before/ After	Actual Values Before /After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-02-P.tcl	DCUFRAMECNT	n/n+700		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.20 Procedure SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P

Version	2.4
Date	6th December 2007
Purpose	Photometer BDAs switch ON check
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are ON.
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	7 minutes
Pass/Fail criteria	DCU HK parameters show expected values

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-11-PHOT-P.tcl	—	—	—	
2	Check that the Photometer detectors and LIAs are switched on	PSWJFETSTAT PMLWJFETSTAT PLIABITSTAT PLIAP5V PLIAP9V PLIAM9V	0/-/0x3F 0/-/0x7F 1 ~0/ ~+5.17 ± 0.1V ~0/ ~+11.53 ± 0.1V ~0/ ~-11.53 ± 0.1V		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.21 Procedure SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs integrity check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	15 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-13-PHOT-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.22 Procedure SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs noise level check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Photometer BDA signals show no excess noise

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-14-PHOT-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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**7.2.2.23 Procedure SPIRE-IST-COLD -PHOT-VSS-P**

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs Vss Test PRIME
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	20 minutes
<b>Pass/Fail criteria</b>	Photometer BDA Vss values are optimised

**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/ Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD - PHOT-VSS-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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Doc. No: HP-2-ASED-TP-0217

Issue: 1

Date: 08.05.08

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7.2.2.24 Procedure SPIRE-IST-COLD-PDET-OFF-P

Version	2.4
Date	6th December 2007
Purpose	Photometer BDAs Switch OFF
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are ON
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Photometer BDAs are OFF
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	3 minutes
Pass/Fail criteria	DCU HK parameters show expected values

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Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-PDET-OFF-P.tcl	—	—	—	
2	Check that the Photometer detectors are switched off	PSWJFETSTAT PMLWJFETSTAT	0x3F/-0 0x7F/-0		
3	Check that the Photometer LIAs are switched off	PLIABITSTAT	1/-0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.2.25 Procedure SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs switch ON check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	7 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-11-SPEC-P.tcl	—	—	—	
2	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT SLIAP5V SLIAP9V SLIAM9V	0/-/7 1 ~0/ ~+5.23 ± 0.1 ~0/ ~+11.57 ± 0.1 ~0/ ~-11.54 ± 0.1		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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**7.2.2.26 Procedure SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P**

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs integrity check
<b>Initial configuration</b>	SPIRE DPU and DRUC PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRUC PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	12 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-13-SPEC-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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**7.2.2.27 Procedure SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P**

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs noise check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Spectrometer BDA signals show no excess noise

**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-14-SPEC-P.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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7.2.2.28 Procedure SPIRE-IST-COLD- SPEC-VSS-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs Vss Test PRIME
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	20 minutes
<b>Pass/Fail criteria</b>	Spectrometer BDA Vss values are optimised

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT	7		
2	Execute TCL script SPIRE-IST-COLD-SPEC-VSS-P.tcl	SLIABITSTAT	1		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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Doc. No: HP-2-ASED-TP-0217

Issue: 1

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7.2.2.29 Procedure SPIRE-IST-COLD-SDET-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and Spectrometer BDAs are OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

**Procedure Steps:**

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-SDET-OFF-P.tcl	—	—		
2	Check that the Spectrometer detectors are switched off	SPECJFETSTAT	7/-/0		
3	Check that the Spectrometer LIAs are switched off	SLIABITSTAT	1/-/0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
<b>Cryostat Check Procedure for CFT</b>							
5	Record Temperatures: T246: (KD223302 if connected to CCU) >10K - <15K T247: (KD223303 if connected to CCU) >10K - <15K						
6	Inform Cryo Engineers that Level 3 temperature no longer needs to be maintained between 10K and 15K	OK					
<b>End of Cryostat Check</b>							

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

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Date: 08.05.08

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7.2.2.30 Procedure SPIRE-IST-COLD-MCU-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU PRIME Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is ON.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK Parameter shows expected value.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-P.tcl	—	—	—	
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.2.32 Switch OFF SPIRE PRIME

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
1.	From the HPCCS test conductor console start the test script to power OFF SPIRE Prime: <b>S102999SCVT032_ASDCFTSPIR_PWR_OFF_P</b>	OK				
2.	On HPCCS when prompted: "SPIRE Switch OFF for CFT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct" <b>Select YES</b>	YES				
	If <b>YES</b> is selected the test script will go on to automatically power off all SPIRE warm units.					

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Date:	08.05.08		

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Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
	Note that during Switch OFF of SPIRE the following (5,2) and (5,4) event messages on APID 1280 may be expected and do not indicate a problem: a) EVID 1313 No_MCU_Response_Error b) EVID 21773 ALARM_LSMCU_DEAD  However, be aware that if FDIR is enabled for SPIRE in the CDMU then this may trigger an OBCP					
3.	On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue"  Check that parameters:  THSK Not refreshing TM2N Not incrementing	2/4		AND: SA_1_559		
4.	Select OK to continue	OK				

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
5.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT032_ASDCFTSPIR_PWR_OFF_P it will prompt: "Bus profile left as SPIRE PRIME, change manually after if required - OK to continue"					
6.	Select OK to continue	OK				
7.	On HPCCS stop Packet History displays for the following APIDs: 1280, 1282	OK				
	<b>SPIRE PRIME OFF</b>					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

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**7.2.3 Cold Functional Tests – Redundant**

**7.2.3.1 Switch ON SPIRE REDUNDANT**

The following will switch ON and configure SPIRE Redundant instrument in REDY (Standby) mode. HKTM packets will be generated on APIDs 1281 dec and 1283 decimal (these can be observed using TMPH with corresponding filter – note however a limited number of TMPHs should be running at one time).

During power on of SPIRE a number of soft/hard OOLs are reported due to the sequential switch on of the units. This is expected and will clear when SPIRE is in REDY mode. When in REDY mode one parameter remains OOL (soft) namely SMD2V505 this is also expected.

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
1.	On HPCCS start Packet History displays for the following APIDs: 1281, 1283	OK				
2.	From the HPCCS test conductor console start the test script to power on SPIRE Redundant: S102999SCVT033_ASDCFTSPIR_PWR_ON_R	OK		AND: ZAD07999, ZAD14999 MIM: LCL_HERSCHEL		

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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Enter Start Date/Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
3.	<p>On HPCCS when prompted:</p> <p>"SPIRE Switch ON for Cold FT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct"</p> <p><b>Select YES</b></p>	YES				
	<p>If <b>YES</b> is selected the test script will go on to automatically power on all SPIRE warm units, force boot the DPU ASW and configure the instrument to Standby mode. Reply to prompts as indicated below.</p>					
4.	<p>On HPCCS when prompted:</p> <p>"Check Telemetry Updating Correctly and OBT is Consistent with CDMU - OK to continue"</p> <p><b>Select OK</b></p>	OK		AND: SA_1_559		
5.	<p>If I-EGSE connected when prompted on HPCCS, perform check requested then select OK:</p> <p>"Check IEGSE Time Consistent - OK to continue when RAL confirm"</p>	OK				

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
6.	<p>On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue"</p> <p>Check that parameters:</p> <p>THSK TM2N</p>	<p>Not refreshing Not incrementing</p>				
	Select OK to continue	OK				
7.	<p>On HPCCS when prompted: "Check Telemetry Updating Correctly - OK to continue"</p> <p>Check that parameters:</p> <p>THSK TM2N</p>	<p>Refreshing @ 1Hz Incrementing by 1 @ 1Hz</p>		AND: SA_1_559		
	Select OK to continue	OK				

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
8.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT033_ASDCFTSPIR_PWR_ON_R it will prompt: "Set Bus Profile Back to Original Setting?" Select NO At the prompt: "Bus Profile left unchanged" Select OK to continue	NO				
9.	Verify HK TM packets are being received on APIDs 1281 & 1283 SPIRE DPU & DRCU Redundant powered	OK				
10.		OK				

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7.2.3.2 Procedure SPIRE-IST-COLD-FUNC-SCU-02-R

Version	2.4
Date	6th December 2007
Purpose	SCU Nominal Science Contents Check REDUNDANT
Initial configuration	SPIRE DPU and DRCU REDUNDANT are switched ON, SPIRE HK is being produced
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE-IST-COLD-DPU-ON-R and SPIRE-IST-COLD-DRCU-ON-R procedures have been executed.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• IEGSE is up and running</li> <li>• DPU AND OBS PARAMETERS &amp; FUNCTIONAL TEST PARAMETERS displays are selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	HK parameters have the expected values

Procedure Steps:

Step	Description	Parameter	Expected Values Before/After	Actual Values Before /After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-02-R.tcl	SCUFRAMECNT TM5N	0/31 0x3FFF/1		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.3 Procedure SPIRE-IST-COLD-FUNC-SCU-03-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCU DC thermometry check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and DC thermometry is ON
<b>Constraints</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	8 minutes
<b>Pass/Fail Criteria</b>	SCU DC thermometry channels show temperature readings according to the actual instrument temperature

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-03-R.tcl	—	—	—	
2	Wait for the parameter BBFULLTYPE to get set to SCU_DC_Therm	—	—	—	

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Enter Start Date|Time: \_\_\_\_\_

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
3	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0/0xFFFF/0xFFFF		
4	If the instrument is at He I temperatures check the values of SCU DC thermometry channels.	PUMPHTRTEMP PUMPHSTEMP EVAPHSTEMP SHUNTTEMP EMCFILTEMP SLOTEMP PLOTEMP OPTTEMP BAFTEMP BSMIFTEMP SCAL2TEMP SCAL4TEMP SCALTEMP SMECIFTEMP SMECTEMP BSMTEMP	(All Values TBC) ~4.2K ~4.4K ~4.3K ~4.2K ~4.8K ~4.2K ~4.2K ~4.8K ~4.8K ~4.7K ~4.8K ~4.8K ~4.8K ~4.7K ~4.7K ~4.8K		
5	If the instrument is at He II temperatures check the values of	PUMPHTRTEMP	(All Values TBC) -/~4.6K		

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
	SCU DC thermometry channels.	PUMPHSTEMP EVAPHSTEMP SHUNTTEMP EMCFILTEMP SLOTTEMP PLOTTEMP OPTTEMP BAFTEMP BSMIFTEMP SCAL2TEMP SCAL4TEMP SCALTEMP SMECIFTEMP SMECTEMP BSMTEMP	-/~3.0K -/~3.0K -/~1.7K -/~4.6K -/~1.7K -/~1.7K -/~4.6K -/~4.6K -/~4.5K -/~4.6K -/~4.6K -/~4.6K -/~4.6K -/~4.6K -/~4.5K		
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

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**7.2.3.4 Procedure SPIRE-IST-COLD-FUNC-SCU-06-R**

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCU AC thermometry check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Constraints</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	2 minutes
<b>Pass/Fail Criteria</b>	SCU AC thermometry channel shows temperature readings according to the actual instrument temperature

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Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-06-R.tcl	—	—	—	
2	Wait for the parameter BBFULLTYPE to get set to SCU_AC_Therm	—	—	—	
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	0/1/1		
4	If the instrument is at He I temperatures check the value of SCU_AC thermometry channel.	SUBKTEMP	~4K		
5	If the instrument is at He II temperatures check the value of SCU_AC thermometry channel.	SUBKTEMP	~1.7K		
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.5 Procedure SPIRE-IST-COLD-FUNC-SCU-07-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Sorption Cooler Heater Check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Constraints</b>	<b>This test should not be performed at He II temperatures, unless specifically instructed to do so by the I-EGSE staff.</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail Criteria</b>	Sorption cooler heat switches and pump heater show expected voltages

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-07-R.tcl	—	—	—	
2	Wait for the parameter BBFULLTYPE to get set to Cooler_Htr_Chk	BBFULLTYPE	Cooler_Htr_Chk		

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Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
3	Record the value of parameter SPHSV – the Sorption Pump Heat Switch Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	SPHSV – mV	0/~323/0		
4	Record the value of parameter EVHSV – the Evaporator Heat Switch Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	EVHSV – mV	0/~323/0		
5	Record the value of parameter SPHTRV – the Sorption Pump Heater Voltage. This voltage stays on for ~20 seconds. Wait for the voltage to go to zero to continue.	SPHTRV – V	0/~8.8/0		
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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Date:	08.05.08		

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**7.2.3.6 Procedure SPIRE-IST-COLD-FUNC-PCAL-01-R**

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	PCAL Characterisation Check (REDUNDANT)
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	Unchanged
<b>Constraints</b>	<b>This test should only be performed at He I or He II temperatures</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail Criteria</b>	PCAL voltage and current agree with expected values

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Procedure Steps:

Step	Description	Parameter Name – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-PCAL-01-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Final Configuration: Unchanged

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7.2.3.7 Procedure SPIRE-IST-COLD-FUNC-SCAL-01-R

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCAL Characterisation Check (REDUNDANT)
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	Unchanged
<b>Constraints</b>	<b>This test should only be performed at He I or He II temperatures. If the test is to be performed at He II temperature then please confirm with I-EGSE staff first.</b>
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	18 minutes
<b>Pass/Fail criteria</b>	SCAL2 and SCAL4 voltage and currents agree with expected values

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCAL-01-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.8 Procedure SPIRE-IST-COLD-FUNC-MCU-01-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU (REDUNDANT) Boot Check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCU voltages and board temperatures show expected 'ON' values

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Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-01-R.tcl	—	—	—	
2	Check that the MCU is booted up successfully	MCUBITSTAT	0/1/1		
3	Check MCU HK parameter values and ensure that the values are refreshing	MCUP5V MCUP14V MCUM14V MCUP15V MCUM15V  MCUMACTEMP MCUSMECTEMP MCUBSMTEMP	~ 5.0 ± 0.2V ~ 14.0 ± 0.5V ~ -14.0 ± 0.5V ~ 15.0 ± 0.5V ~ -15.0 ± 0.5V  ~300K ~300K ~300K		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.9 Procedure SPIRE-IST-COLD-FUNC-MCU-03-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU Nominal Science Contents Check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	Unchanged.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK parameters show expected increment

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-03-R.tcl	MCUFRAMECNT	0/-/297		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.10 Procedure SPIRE-IST-COLD-FUNC-BSM-01-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (REDUNDANT) Chop/Jiggle Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters CHOPSENSEPW and JIGGSENSEPW show expected ON values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-01-R.tcl	—	—	—	
2	Check that the Chop and Jiggle sensors have switched on	CHOPSENSEPW JIGGSENSEPW	0/1/1 0/1/1		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.11 Procedure SPIRE-IST-COLD-FUNC-BSM-03-R

Version	2.4
Date	6th December 2007
Purpose	BSM (REDUNDANT) Open Loop Dynamics Check.
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	CHOPSENSSIG/JIGGSENSIG HK parameter evolve in the same direction as the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-03-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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Date:	08.05.08		

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7.2.3.12 Procedure SPIRE-IST-COLD-FUNC-BSM-05A-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (REDUNDANT) Open Loop Chop Test
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	The BSM Chops between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-05A-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.13 Procedure SPIRE-IST-COLD-FUNC-BSM-05B-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (REDUNDANT) Close Loop Chop Test
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON.
<b>Final configuration</b>	BSM is in closed loop mode
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• CHOP PARAMETERS and JIGGLE PARAMETERS displays are selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	The BSM Chops in between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-INIT-R.tcl	CHOPLOOPMODE	3/-/1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-BSM-05B-R.tcl	JIGGLOOPMODE	3/-/1		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.14 Procedure SPIRE-IST-COLD-FUNC-BSM-06-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (REDUNDANT) Closed Loop Operational Mode Chop Test
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON. BSM is in closed loop.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• CHOP PARAMETERS and JIGGLE PARAMETERS displays are selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	The BSM Chops between the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-06-R.tcl	CHOPLOOPMODE JIGGLOOPMODE	1/1/1 1/1/1		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.15 Procedure SPIRE-IST-COLD-BSM-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	BSM (REDUNDANT) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. BSM Chop/Jiggle sensors are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters CHOPSENSPWR and JIGGSENSPWR show expected OFF values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-BSM-OFF-R.tcl	—	—	—	
2	Check that the power to the BSM sensors is switched off	CHOPSENSPWR JIGGSENSPWR	1/-/0 1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.16 Procedure SPIRE-IST-COLD-FUNC-SMEC-01-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Encoder/LVDT Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECECNPWR and SMECLVDTPWR show expected ON values.

**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-01-R.tcl	—	—	—	
2	Check that power to the SMEC LED and LVDT sensor is on	SMECECNPWR SMECLVDTPWR	0/-/2 0/-/1		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.17 Procedure SPIRE-IST-COLD-FUNC-SMEC-03-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Encoder Integrity Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCUENGSMECECNSIG1/2 increase as the encoder power is increased

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-03-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.18 Procedure SPIRE-IST-COLD-SMEC-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENCPCR and SMECLVDTPCR show expected OFF values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-SMEC-OFF-R.tcl	—	—	—	
2	Check that the power to the SMEC sensors is switched off	SMECENCPCR SMECLVDTPCR	2/-/0 1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.3.19 Procedure SPIRE-IST-COLD-FUNC-DCU-02-R

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
<b>Cryostat Check Procedure for CFT</b>							
2	Prior to performing next step verify that Level 3 temperature is between 10K and 15K (sensors T246 & T247)	OK					
3	Record Temperatures: T246: (KD223302 if connected to CCU) >10K - <15K T247: (KD223303 if connected to CCU) >10K - <15K						
<b>End of Cryostat Check</b>							

N/A

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	DCU Nominal Science Contents Check REDUNDANT
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are switched ON, SPIRE HK is being produced and MCU is booted.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE-IST-COLD-DPU-ON-R and SPIRE-IST-COLD-DRCU-ON-R procedures have been executed.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• I-EGSE is up and running</li> <li>• DCU PARAMETERS display is selected on the CCS</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters increment as expected

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Procedure Steps:

Step	Description	Parameter	Expected Values Before/After	Actual Values Before/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-02-R.tcl	DCUFRAMECNT	n/n+700		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.20 Procedure SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs switch ON check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	7 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

2/1

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Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-11-PHOT-R.tcl	—	—	—	
2	Check that the Photometer detectors and LIAs are switched on	PSWJFETSTAT PMLWJFETSTAT PLIABITSTAT PLIAP5V PLIAP9V PLIAM9V	0/-/0x3F 0/-/0x7F 1 ~0/ ~+5.19 ± 0.1V ~0/ ~+11.54 ± 0.1V ~0/ ~-11.53 ± 0.1V		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.21 Procedure SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs integrity check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	15 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-13-PHOT-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.22 Procedure SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs noise level check
<b>Initial configuration</b>	SPIRE DPU and DRUC REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRUC REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Photometer BDA signals show no excess noise

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-14-PHOT-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.23 Procedure SPIRE-IST-COLD -PHOT-VSS-R

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs Vss Test REDUNDANT
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	20 minutes
<b>Pass/Fail criteria</b>	Photometer BDA Vss values are optimised

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that Photometer LIAs and detectors are switched on	PLIABITSTAT PSWJFETSTAT PMLWJFETSTAT	1 0x3F 0x7F		
2	Execute TCL script SPIRE-IST-COLD - PHOT-VSS-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.24 Procedure SPIRE-IST-COLD-PDET-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Photometer BDAs Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are ON
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Photometer BDAs are OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	DCU/HK parameters show expected values

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**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-PDET-OFF-R.tcl	—	—	—	
2	Check that the Photometer detectors are switched off	PSWJFETSTAT PMLWJFETSTAT	0x3F/-/0 0x7F/-/0		
3	Check that the Photometer LIAs are switched off	PLIABITSTAT	1/-/0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.25 Procedure SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs switch ON check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	7 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-11-SPEC-R.tcl	—	—	—	
2	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT SLIAP5V SLIAP9V SLIAM9V	0/-/7 1 ~0/ ~+5.23 ± 0.1 ~0/ ~+11.57 ± 0.1 ~0/ ~-11.54 ± 0.1		
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.26 Procedure SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs integrity check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	12 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-13-SPEC-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.27 Procedure SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs noise check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Spectrometer BDA signals show no excess noise

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD-FUNC-DCU-14-SPEC-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.28 Procedure SPIRE-IST-COLD- SPEC-VSS-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs Vss Test REDUNDANT
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	20 minutes
<b>Pass/Fail criteria</b>	Spectrometer BDA Vss values are optimised

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Check that the Spectrometer detectors and LIAs are switched on	SPECJFETSTAT SLIABITSTAT	7 1		
2	Execute TCL script SPIRE-IST-COLD-SPEC-VSS-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.3.29 Procedure SPIRE-IST-COLD-SDET-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Spectrometer BDAs Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are ON
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and Spectrometer BDAs are OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	DCU HK parameters show expected values

**Procedure Steps:**

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-SDET-OFF-R.tcl	—	—		
2	Check that the Spectrometer detectors are switched off	SPECJFETSTAT	7/-/0		
3	Check that the Spectrometer LIAs are switched off	SLIABITSTAT	1/-/0		
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
<b>Cryostat Check Procedure for CFT</b>							
5	Record Temperatures: T246: (KD223302 if connected to CCU) T247: (KD223303 if connected to CCU)	>10K - <15K >10K - <15K					
6	Inform Cryo Engineers that Level 3 temperature no longer needs to be maintained/between 10K and 15K	OK					
<b>End of Cryostat Check</b>							

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7.2.3.30 Procedure SPIRE-IST-COLD-MCU-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU REDUNDANT Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is ON.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK Parameter shows expected value.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-R.tcl	—	—	—	
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0		
<b>Test Result (Pass/Fail):</b>					

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**7.2.3.31 Procedure SPIRE-IST-COLD-SCU-OFF-R**

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCU REDUNDANT Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified SCU HK Parameters show expected value.

**Procedure Steps:**

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Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-SCU-OFF-R.tcl	—	—	—	
2	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0xFFFF/-0		
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	1/-0		
<b>Test Result (Pass/Fail):</b>					

2

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7.2.3.32 Switch OFF SPIRE REDUNDANT

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
1.	From the HPCCS test conductor console start the test script to power OFF SPIRE REDUNDANT:  S102999SCVT034_ASDCFTSPIR_PWR_OFF_R	OK				
2.	On HPCCS when prompted:  "SPIRE Switch OFF for CFT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct"  Select YES					
	If YES is selected the test script will go on to automatically power off all SPIRE warm units.					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
	<p>Note: During Switch OFF of SPIRE, the following (5,1) and (5,4) event messages on APID 1281 may be expected and do not indicate a problem:</p> <p>c) EVID 1313 No_MCU_Response_Error d) EVID 21773 ALARM_LSMCU_DEAD</p> <p>However, be aware that if FDIR is enabled for SPIRE in the CDMU then this may trigger an OBCP</p>					
3.	<p>On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue"</p> <p>Check that parameters:</p>	<p>2/1/14</p> <p>THSK Not refreshing TM2N Not incrementing OK</p>		AND: SA_1_559		
4.	Select OK to continue					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
5.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT034_ASDCFTSPIR_PWR_OFF_R it will prompt: "Bus profile left as SPIRE PRIME, change manually after if required - OK to continue"					
6.	Select OK to continue	OK				
7.	On HPCCS stop Packet History displays for the following APIDs:1281,1283	OK				
	<b>SPIRE REDUNDANT OFF</b>					

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**7.2.4 Satellite & EGSE Switch Off After CFT Tests**

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	P	N
	<b>Satellite &amp; EGSE Switch Off</b>					
	Initial Conditions: Nominal & Redundant SPIRE warm units OFF					
1	On HPCSS terminate <b>ALL_SubscribeParams.tcl</b> test script.	OK				
2	From HPCSS Test Conductor console issue command to disconnect from SPIRE I-EGSE	OK				
3	disconnect <b>HSPREEGSE</b>	OK				
3	Confirm from HPCSS and SPIRE I-EGSE that the disconnection was successful	YZS29940= DISCONNECTED				AND SYS_PARS
4	If no longer required switch OFF I-EGSE i.a.w. AD 5	OK				
5	Power OFF i.a.w. AD 10 section TBD (1ST END for SPIRE Commissioning)	OK				
6	Confirm both Satellite and EGSE powered down	OK				
	End Conditions: Satellite and EGSE OFF					
	<b>END OF SPIRE CFT TEST</b>					

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7.2.5 EGSE & Satellite Switch On for SMEC Tests

*0 Confirm all constraints for the SMEC Test as defined in section A, have been fulfilled prior to starting the test.*

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
	<b>Satellite &amp; EGSE Switch On</b>						
1	Confirm I-EGSE physically connected to HPCCS	OK		OK		7	
2	Switch on & configure SPIRE I-EGSE i.a.w. AD5 & AD 8	OK		OK		7	
3	Confirm SPIRE I-EGSE is in the correct configuration as per AD5 & AD 8	OK		OK		7	
4	Switch on HPCCS, SCOE and Satellite/SVM and configure into Basic Test Mode i.a.w. AD 2 Section 7.1 to 7.5.	OK		Already ON see PARS		7	
5	Confirm that EGSE and Satellite are in the correct configuration as per AD 2	OK		OK		7	
6	If not already on, from HPCCS power ON CCU A & CCU B by executing test script: <b>K102999ECVT001_ASDGENCCU_ABPWRON</b>	OK		Already ON		7	
7	If not already enabled, from HPCCS enable Monitoring Mode 1 (512sec cycle) for CCU A & B by executing test script: <b>K102999ECVT001_ASDGENCCU_MnEBOTH1</b>	OK		Already ON in Mode 2		7	
8	From HPCCS Test Conductor console issue command to connect to SPIRE I-EGSE <b>connect HSPIREEGSE</b>	OK		OK		7	
9	Confirm from HPCCS and SPIRE I-EGSE that the connection has been established	YZS29940=CONNECTED		CONNECTED	AND SYS_PARS	7	
10	Verify that I-EGSE is receiving CCU Cryo packets	OK		OK		7	

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Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
11	On HPCCS start the following test script: ALL_SubscribeParams.tcl	OK		OK		1	
12	Verify HPCCS-IEGSE connection by sending test command: YC00X066 From the manual command stack (repeater value of "0")	OK		OK		1	
13	If required load Synoptics INSTRUMENTS on HPCCS to display SPIRE status overview	OK		OK		1	
<b>READY FOR START OF SPIRE SMEC TESTS</b>							

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**7.2.6 SMEC Tests**

**7.2.6.1 Switch ON for SPIRE PRIME SMEC**

The following will switch ON and configure SPIRE Prime instrument in REDY (Standby) mode. HKTM packets will be generated on APIDs 1280 dec and 1282 decimal (these can be observed using TMPH with corresponding filter – note however a limited number of TMPHs should be running at one time).

During power on of SPIRE a number of soft/hard OOLs are reported due to the sequential switch on of the units. This is expected and will clear when SPIRE is in REDY mode. When in REDY mode one parameter remains OOL (soft) namely SMD2V505 this is also expected.

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
11.	On HPCCS start Packet History displays for the following APIDs:1280,1282	OK	OK		✓	
12.	From the HPCCS test conductor console start the test script to power on SPIRE Prime: S102999SCVT031_ASDCFTSPIR_PWR_ON_P	OK	OK	AND: ZAD07999, ZAD14999 MIM: LCL_HERSCHEL	✓	

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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
13.	On HPCCS when prompted: "SPIRE Switch ON for Cold FT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct" <b>Select YES</b>	YES	YES		7	
	If <b>YES</b> is selected the test script will go on to automatically power on all SPIRE warm units, force boot the DPU ASW and configure the instrument to Standby mode. Reply to prompts as indicated below.					
14.	On HPCCS when prompted: "Check Telemetry Updating Correctly and OBT is Consistent with CDMU - OK to continue" <b>Select OK</b>	OK	OK	AND: SA_1_559	7	

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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
15.	If I-EGSE connected when prompted on HPCCS, perform check requested then select OK: "Check IEGSE Time Consistent - OK to continue when RAL confirm" On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue" Check that parameters: Select OK to continue	OK	OK		✓	
16.	THSK TM2N Check that parameters: Select OK to continue	Not refreshing Not incrementing OK	OK		✓	
17.	On HPCCS when prompted: "Check Telemetry Updating Correctly - OK to continue" Check that parameters: Select OK to continue	THSK Refreshing @ 1Hz TM2N Incrementing by 1 @ 1Hz OK	OK	AND: SA_1_559 Expected command for wife's 2x SUCCESS	✓	

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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
18.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT031_ASDCFTSPIR_PWR_ON_P it will prompt: "Set Bus Profile Back to Original Setting?" Select NO	NO	NO		1	
19.	At the prompt: "Bus Profile left unchanged" Select OK to continue	OK	OK		1	
20.	Verify HK TM packets are being received on APIDs 1280 & 1282	OK	OK		1	
	<b>SPIRE DPU &amp; DRCU powered</b>					

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7.2.6.2 Procedure SPIRE-IST-COLD-FUNC-MCU-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU (PRIME) Boot Check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCU voltages and board temperatures show expected 'ON' values

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Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-01-P.tcl	—	—	—	✓
2	Check that the MCU is booted up successfully	MCUBITSTAT	0/1/1	1	✓
3	Check MCU HK parameter values and ensure that the values are refreshing	MCUP5V MCUP14V MCUM14V MCUP15V MCUM15V MCUMACTEMP MCUSMECTEMP MCUBSMTTEMP	~ 5.0 ± 0.2V ~ 14.0 ± 0.5V ~ -14.0 ± 0.5V ~ 15.0 ± 0.5V ~ -15.0 ± 0.5V ~300K ~300K ~300K	5.01 14.15 -14.47 15.55 -15.63 ~292.9 ~297.0 ~297.1	✓
<b>Test Result (Pass/Fail):</b>					

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File: SPIRE FM IST Inst Comm CFT TP HP-2-ASED-TP-0217 Iss1.doc

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7.2.6.3 Procedure SPIRE-IST-COLD-FUNC-MCU-03-P

Version	2.4
Date	6th December 2007
Purpose	MCU Nominal Science Contents Check
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
Final configuration	Unchanged.
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	Specified MCU HK parameters show expected increment

Procedure Steps:

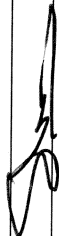
Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-03-P.tcl	MCUFRAMECNT	0/-297	0/297	✓
<b>Test Result (Pass/Fail):</b>					

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7.2.6.4 Procedure SPIRE-IST-COLD-FUNC-SMEC-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Encoder/LVDT Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENC PWR and SMECLVDT PWR show expected ON values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-01-P.tcl	—	—	—	✓
2	Check that power to the SMEC LED and LVDT sensor is on	SMECENC PWR SMECLVDT PWR	0/-/1 0/-/1	0 / 1 0 / 1	✓
<b>Test Result (Pass/Fail):</b>					

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7.2.6.5 Procedure SPIRE-IST-COLD-FUNC-SMEC-03-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Encoder Integrity Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCUENGSMECENC SIG1/2 increase as the encoder power is increased

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-03-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	✓
<b>Test Result (Pass/Fail):</b>					

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7.2.6.6 Procedure SPIRE-IST-COLD-FUNC-SMEC-02A-P

Version	2.4
Date	6th December 2007
Purpose	Open the SMEC Launch Latch Prime (Unlatch it)
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is latched
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is ON and Unlatched
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	5 minutes
Pass/Fail criteria	The SMEC latch is open.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-02A-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	✓
<b>Test Result (Pass/Fail):</b>					

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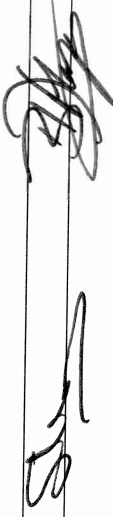
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7.2.6.7 Procedure SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P

Version	1.0
Date	6 <sup>th</sup> December 2007
Purpose	SMEC (PRIME) Open Loop Feed Forward Offset Test
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	40 minutes
Pass/Fail criteria	Optimum SMEC Feed Forward Offset is determined

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

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Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
3	<p>Based on the results of this test it may be necessary to set the SMEC FF Offset manually.</p> <p>SPIRE_SEND_DRCU_COMMAND</p> <ul style="list-style-type: none"> <li>param 1 = 0x9055xxxx</li> <li>param 2 = 0</li> </ul> <p>I-EGSE staff will supply the 16-bit parameter value xxxx to this command.</p>	SMECFFOFFSET	-/- /xxxx 7530		
4	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p>SPIRE_SEND_DRCU_COMMAND</p> <ul style="list-style-type: none"> <li>param 1 = 0x9058xxxx</li> <li>param 2 = 0</li> </ul> <p>SPIRE_SEND_DRCU_COMMAND</p> <ul style="list-style-type: none"> <li>param 1 = 0x905Axxxx</li> <li>param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	SMECENC SIG1OFF  SMECENC SIG2OFF	-/-~ Commanded Value  -/-~ Commanded Value		skipped

AVS 6 →  
AVS 7 →  
AVS 8 →



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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
5	Note that it may be necessary to repeat this test to fine tune the Feed Forward Offset	—	—	—	
<b>Test Result (Pass/Fail):</b>					



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7.2.6.8 Procedure SPIRE-IST-COLD-FUNC-SMEC-FFGAIN-P

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step 8.*

Version	1.0
Date	6 <sup>th</sup> December 2007
Purpose	SMEC (PRIME) Open Loop Scan Test for different Feed Forward Gain settings
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>SPIRE DRCU PRIME is switched ON</li> <li>SPIRE MCU PRIME is booted.</li> <li>SPIRE MIB PRIME is imported in the CCS database.</li> <li>CCS is up and running</li> <li>SMEC PARAMETERS display is selected on the CCS</li> <li>The Herschel Cryostat should be tilted horizontal</li> <li>Test SPIRE-IST-COLD-FUNC-SMEC-FFGAIN-P has been executed successfully</li> </ul>
Duration	100 minutes
Pass/Fail criteria	Optimum SMEC Feed Forward Gain is determined

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-FFGAIN-P.tcl	—	—	—	
2	<b>Wait for the I-EGSE staff to confirm the success or failure of this test</b>	—	—	—	
3	Based on the results of this test it may be necessary to set the SMEC FF Gain manually.  <b>SPIRE_SEND_DRCU_COMMAND</b> <ul style="list-style-type: none"> <li>• param 1 = 0x9054xxxx</li> <li>• param 2 = 0</li> </ul> I-EGSE staff will supply the 16-bit parameter value xxxx to this command.	SMECFFGAIN	- / - /xxxx		

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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
4	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x9058xxxx</li> <li>param 2 = 0</li> </ul> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x905Axxxx</li> <li>param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	<p>SMECENC SIG1 OFF</p> <p>SMECENC SIG2 OFF</p>	<p>-/-~ Commanded Value</p> <p>-/-~ Commanded Value</p>		
5	<p>Note that it may be necessary to repeat this test to fine tune the Feed Forward Gain</p>	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.9 Procedure SPIRE-IST-COLD-FUNC-SMEC-04A-P

Version	2.4
Date	6th December 2007
Purpose	SMEC (PRIME) Open Loop Positioning Test.
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• The Herschel Cryostat should be tilted horizontal</li> </ul>
Duration	5 minutes
Pass/Fail criteria	SMEC moves to the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-04A-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.10 Procedure SPIRE-IST-COLD-FUNC-SMEC-09-P

Version	2.4
Date	6th December 2007
Purpose	SMEC (PRIME) Open Loop Scan Test.
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	5 minutes
Pass/Fail criteria	SMEC performs a scan between the commanded positions

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Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p>SPIRE_SEND_DRCU_COMMAND</p> <ul style="list-style-type: none"> <li>param 1 = 0x9058xxxx</li> <li>param 2 = 0</li> </ul> <p>SPIRE_SEND_DRCU_COMMAND</p> <ul style="list-style-type: none"> <li>param 1 = 0x905Axxxx</li> <li>param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	<p>SMECENC SIG1OFF</p> <p>SMECENC SIG2OFF</p>	<p>-/- Commanded Value = 0x90589c40</p> <p>-/- Commanded Value = 0x905A8888</p>	<p>First command sent as 0x90580000 reset with correct value</p>	<p>✓</p> <p>✓</p>
2	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-09-P.tcl	-	-	-	✓
3	Wait for the I-EGSE staff to confirm the success or failure of this test	-	-	-	
Test Result (Pass/Fail):					

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7.2.6.11 Procedure SPIRE-IST-COLD-FUNC-SMEC-07-P

Version	2.4
Date	6th December 2007
Purpose	SMEC (PRIME) Close Loop Scan Test.
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	SMEC is in closed loop
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	10 minutes
Pass/Fail criteria	SMEC performs a scan between the commanded positions and the loop remains closed

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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Before this test a SMEC calibration table on the I-EGSE may have to be changed. Please confirm with the I-EGSE staff before continuing with the next test.	—	—	—	
2	Execute TCL script SPIRE-IST-COLD-SMEC-INIT-P.tcl	SMECLOOPMODE	6/-/1		
3	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-07-P.tcl	—	—	—	
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.12 Procedure SPIRE-IST-COLD-FUNC-SMEC-04B-P

Version	2.4
Date	6th December 2007
Purpose	SMEC (PRIME) Close Loop Positioning Test.
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON. SMEC is in closed loop.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	10 minutes
Pass/Fail criteria	SMEC moves to the commanded positions and remains in closed loop

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-04B-P.tcl	SMECLOOPMODE	1/1/1		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.13 Procedure SPIRE-IST-COLD-FUNC-SMEC-LVDT-P

Version	1.0
Date	6th December 2007
Purpose	SMEC (PRIME) Backup LVDT Close Loop Check
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON. SMEC is in closed loop.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	90 minutes
Pass/Fail criteria	SMEC remains in-closed loop on LVDT

*deleted see TVSA's*

*ok*

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-LVDT-P.tcl	SMECLOOPMODE	1/-/4		
2	Manual commanding may be necessary during this test. Details to be specified	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date | Time: \_\_\_\_\_

*Pass 11  
 Step 4*

7.2.6.14 SMEC Microvibration Pre-Test Configuration

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
	<b>ACMS Switch ON</b>						
1	From Test Conductor Console, execute script: 'A102109SPVT003_ACMS_CONFIG25'	OK					
2	At the following main menu: HERSCHEL/PLANCK - MAIN MENU 1.0 - INIT PHASE =====						
	<ol style="list-style-type: none"> <li>1. Select/Load ACMS_CONFIG Input File</li> <li>2. Perform LAUNCH CONFIGURATION</li> <li>3. On Board SW Updates</li> <li>4. ACMS Power ON (in Pre-Sep configuration)</li> <li>5. Modify ACC SGM/RM CONTENT (Enter sub-menu 1.1)</li> <li>6. ACMS SCOE Configuration</li> </ol>	Continue					
	77. JUMP to another Entry Point						
	88. Continue ACMS_CONFIG to menu 2.0 STBY/PRE-SEP						
	99. Terminate ACMS_CONFIG						

*Steps 11#*

*RS*

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date|Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
3	<p><u>select the point number 1</u> and press the relevant button: "CONTINUE".</p> <p>Sequence pops-up asking for the input file. Write SPIRE_UV and press OK</p>	Write "SPIRE_UV" and press OK					
4	<p>At sequence completion, the same main menu appears.</p> <p>Select <i>point number 6</i> to <b>switch on the ACMS SCOE</b> then <b>click OK, Continue</b></p>	Select Option 6 and click OK, Continue	PSM		ACMS SCOE is switched-on in 'executing' mode. Note: Until ACC is not fully powered-on, some WARNING ALARMS might come down in the On-Board Event History.		
5	<p>On AND YA001939 'AMCS SCOE - AS_PSEUDO 1 of 1' check that parameters:</p> <p>YMACT939 (ACMS SCOE state) YMASE939 (Simulator stata) YMAMS939 (MILFE state) YMAUS939 (UIFE state)</p> <p>Turned to: 'executing'</p>	Parameters set to 'executing'					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
6	At sequence completion, the same main menu appears.  Select point number 4 to switch on the ACC then click OK, Continue	Select Option 4 and click OK, Continue			Expected Out of Limit of AEYYYY109 (synchronisation). ACC may become INVALID for a short time.  SPR 245: Out of Limit of HKA_ANTHx_Data		
7	From a Packet History tool, select filter 'APID 512' and check that ACMS HK and ETM is correctly flowing down.	OK					
8	From On-Board Event History Display check that no 'NO-GO' are present.	OK					
9	From ACMS MASTER (ACMS_CONFIG25) sequence, move to Menu 3 (if not already there) with option 88. Click OK and then Confirm	OK					
10	From ACMS_CONFIG25, Menu 3, select option 1: 'Override Separation Flag' then Click button OK and then Confirm	Select 1, then OK and Continue			ACC goes in SAM Mode		

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date|Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
11	Sequence A102109SPVT034_ACMS_SAM_MON shall pop-up following the opening of separation straps, at prompt: 'Do you want to continue to monitor Sam Sun Pointing mode ? Enter your choice: no Then click OK	no			ACMS SAM Point Coarse is reached		
12	From ACMS_CONFIG25 Master Sequence, Menu 4.0, select option 6 'Transition to OCM' <b>Click OK and then Confirm</b>	Select 6, then OK and Continue					
13	Sequence 'A102109SPVT036_ACMS_STR_ON' shall pop-up. At prompt: 'Do You want to change current Str in Use' check if STR already selected is the correct one and answer 'no'	No			STR-1 is switched ON and put in ATFAD mode		
14	When scripts are completed, From ACMS synoptic check that ACC Mode is turned to: 'OCM pnt coarse'	OK					
	Synchronise CCS Time With ETS for Accelerometer Measurement Timing						

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
15	For correlation of test results, record time of ETS Accelerometer Test Equipment and at the same time record the CCS time:  ETS Time (Accelerometer Measurement T.E. Clock): CCS Time:						
16	If not already active request ETS to start accelerometer acquisitions as per Appendix 2						

FIG 11.4

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time:	
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7.2.6.15 Reaction Wheel Operation for Variable Frequency Microvibration

This section should be performed in parallel with section 7.2.6.16 step 3. It takes approximately 40 mins to run.

*PVSU  
step 4  
1*

Step	Reaction Wheel Activation	Nominal Value	Tolerance	Actual Value	Remark	P	N
1	From Test Conductor Console, execute script: <i>213</i> 'A102109SPVT208_ACMS_RWL_SPIRE_uVIB'	OK					
2	Setup the 'TM Plotting Tool' to follow RWL spinning for the following monitoring parameters: AEWR1002 AEWR2002 AEWR3002 AEWR4002	OK					
3	At the following prompt: 'Positive Spin. Click OK' Check from ACMS Synoptic that RWL 1-2-3-4 are ON. Then Click OK to start positive spinning	Click OK					
4	On the 'TM Plotting Tool' follow RWL positive spinning At the following prompt: 'Negative Spin. Click OK' Click OK to start negative spinning	Click OK					

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step	Reaction Wheel Activation	Nominal Value	Tolerance	Actual Value	Remark	P	N
6	On the 'TM Plotting Tool' follow RWL negative spinning At the following prompt: 'Click OK to spin-down RWL to 0 [Nms]' Click OK to bring RWLs to 0 [Nms]	Click OK					

*PLM14*

Enter Date/Time:		Sign Off:	
Doc. No:	HP-2-ASED-TP-0217		
Issue:	1		
Date:	08.05.08		

Enter Start Date|Time:

7.2.6.16 SMEC Variable Frequency Microvibration Test

The previous section (7.2.6.15) must be performed in parallel with this section step 3, which is assumed to take around 40 mins to run. Make sure that for this micro-vibration test the accelerometer acquisition has been activated before continuing.

*ASIN  
Step 4*

Step	Description	Parameters	Expected Values	Actual Values	Success/Failure
1	Execute stand alone script SPIRE-IST-SMEC-RAMP-MICROVIBRATION.tcl Generate high rate MCU engineering data – we are looking for fluctuations in SMEC velocity Set SMEC continuously scanning at 0.5 mm/s (TBC) over full range Number of scans set to make this a 1 hour test  <b>An ABORT TEST pop up should visibe on the operator screen – only press if advised by I-EGSE staff.</b>  <b>When given the go-ahead from SPIRE I-EGSE Operator, perform the following step</b>	N/A <i>11.4</i>	N/A	N/A	
2	Perform Section 7.2.6.15 to start reaction wheel operation i.a.w. agreed profile (see Appendix 2)	N/A	N/A	N/A	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: Sign Off:

Doc. No: HP-2-ASED-TP-0217  
Issue: 1  
Date: 08.05.08

Enter Start Date/Time:	
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7-2-6-17 Reaction Wheel Operation for Spot Frequency Microvibration

This section should be performed in parallel with section 7-2-6-18 step 3. It takes approximately 40 mins to run.

Step	Reaction Wheel Activation	Nominal Value	Tolerance	Actual Value	Remark	P	N
1	From Test Conductor Console, execute script: 'A102109SPVT208_ACMS_RWL_SPIRE_uVIB'	OK					
2	Setup the TM Plotting Tool to follow RWL spinning for the following monitoring parameters: AEWR1002 AEWR2002 AEWR3002 AEWR4002	OK					
3	At the following prompt: 'Positive Spin..Click OK' Check from ACMS Synoptic that RWL 1-2-3-4 are ON. Then Click OK to start positive spinning	Click-OK					
4	On the 'TM Plotting Tool' follow RWL positive spinning At the following prompt: 'Negative Spin..Click OK' Click OK to start negative spinning	Click-OK					

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step	Reaction Wheel Activation	Nominal Value	Tolerance	Actual Value	Remark	P	N
6	On the 'TM Plotting Tool' follow RWL negative spinning At the following prompt: 'Click-OK to spin-down RWL to 0 [Nms]' Click-OK to bring RWLs to 0 [Nms]	Click-OK					

Enter Date/Time:		Sign Off:	
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Doc. No: HP-2-ASED-TP-0217  
 Issue: 1  
 Date: 08.05.08

<b>Enter Start Date/Time:</b>	
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7.2.6.18 SMEC Spot Frequency Microvibration Test

The previous section (7.2.6.16) must be performed in parallel with this section step 3, which is assumed to take around 40 mins to run. Make sure that for this micro-vibration test the accelerometer acquisition has been activated before continuing.

Step	Description	Parameters	Expected Values	Actual Values	Success/Failure
1	On-HPCCS execute test script SPIRE-IST-SMEC-SPOT-MICROVIBRATION Generate high rate data—we are looking for fluctuations in SMEC velocity Scan SMEC at 0.1 mm/s over full range for four scans <b>The following 2 steps shall be run in parallel</b>	N/A	N/A	N/A	
2	Perform Section 7.2.6.15 to start reaction wheel operation i.a.w. agreed profile (see Appendix 2)	N/A	N/A	N/A	
3	On-HPCCS execute test script SPIRE-IST-SMEC-SPOT-MICROVIBRATION Generate high rate data—we are looking for fluctuations in SMEC velocity Scan SMEC at 0.1 mm/s over full range for four scans	N/A	N/A	N/A	
<b>Test Result (Pass/Fail):</b>					

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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Doc. No: HP-2-ASED-TP-0217  
 Issue: 1  
 Date: 08.05.08

Enter Start Date/Time: \_\_\_\_\_

7.2.6.19 Microvibration Post-Test Configuration

AVSU  
Step 4

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
	<b>ACMS Switch OFF</b>						
7.5.5.12.1	Ensure RWLs have spun down before switching OFF						
7.5.5.12.2	From ACMS_CONFIG25 main menu: <ul style="list-style-type: none"> <li>Select the point number 99</li> </ul> and confirm the selection pressing the relevant button "CONTINUE". The following menu will appear: HERSCHEL/PLANCK - MAIN MENU 9.0 - ACMS OFF PHASE ===== <u>select the point number 1</u> 'Switch Off ACMS' and confirm the selection pressing the relevant button "CONTINUE".	Continue					
7.5.5.12.3	Check the "ACMS_OFF" Test Sequence has been successfully ended.	OK					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date|Time: \_\_\_\_\_

Step-No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	Remarks	P	N
7.5.5.12.5	By the same above menu,  <i>select the point number 99</i> to end the ACMS_CONFIG25 Master Sequence". Click OK to Confirm	OK	1.4				
7.5.5.12.6	Re-Synchronise Time With ETS for Accelerometer Measurement Timing  For correlation of test results re-record time of ETS Accelerometer Test Equipment and at the same time record the CCS time:  ETS Time (Accelerometer Measurement T.E. Clock):  CCS Time:	9.55					
7.5.5.12.7	Notify ETS that accelerometer acquisitions can be stopped						

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: 16/05/08 19:09

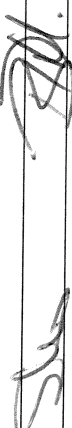
7.2.6.20 Procedure SPIRE-IST-COLD-FUNC-SMEC-02B-P

Version	2.4
Date	6th December 2007
Purpose	Close the SMEC Launch Latch (Latch it)
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is ON and unlatched
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is ON and Latched
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	The SMEC latch is closed

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-02B-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	✓
Test Result (Pass/Fail):					

PVS 10  
 PVS 11  
 PVS 2

Enter Date/Time: 16/05/08 19:13 Sign Off: 



Enter Start Date/Time: 16/05/08 19:21

7.2.6.21 Procedure SPIRE-IST-COLD-SMEC-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENC PWR and SMECLVDTPWR show expected OFF values.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-SMEC-OFF-P.tcl	—	—	—	✓
2	Check that the power to the SMEC sensors is switched off	SMECENC PWR SMECLVDTPWR	1/-/0 1/-/0	0 0	✓
<b>Test Result (Pass/Fail):</b>					

RVS10

Enter Date/Time: 16/05/08 19:22 Sign Off: *[Signature]*

Enter Start Date/Time: 16/05/08 19:22

7.2.6.22 Procedure SPIRE-IST-COLD-MCU-OFF-P

Version	2.4
Date	6th December 2007
Purpose	MCU PRIME Switch OFF
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is OFF.
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is ON.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	Specified MCU HK Parameter shows expected value.


Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-P.tcl	—	—	—	✓
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0	0	✓
<b>Test Result (Pass/Fail):</b>					

*PVS 2*  
*Step 4*  
*(Switch off)*

*PVS 10*

*PVS 2 Step 4 -> SCU off.*

Enter Date/Time: 16/05/08 19:22 Sign Off: 

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Issue: 1

Date: 08.05.08

Enter Start Date/Time: 16/05/08 19:29


7.2.6.23 Switch OFF After SPIRE PRIME SMEC

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
8.	From the HPCCS test conductor console start the test script to power OFF SPIRE Prime: S102999SCVT032_ASDFCFTSPIR_PWR_OFF_P	OK	OK		✓	
9.	On HPCCS when prompted: "SPIRE Switch OFF for CFT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct" <b>Select YES</b> If <b>YES</b> is selected the test script will go on to automatically power off all SPIRE warm units.	YES	YES		✓	

Enter Date/Time: 16/05/08 19:29 Sign Off: [Signature] 3. Hogg

Enter Start Date/Time: 16/05/08

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
	Note that during Switch OFF of SPIRE the following (5,2) and (5,4) event messages on APID 1280 may be expected and do not indicate a problem: e) EVID 1313 No_MCU_Response_Error f) EVID 21773 ALARM_LSMCU_DEAD  However, be aware that if FDIR is enabled for SPIRE in the CDMU then this may trigger an OBCP		Not observed		1	
10.	On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue" Check that parameters: THSK Not refreshing TM2N Not incrementing		OK	AND: SA_1_559	1	
11.	Select OK to continue		OK		1	



Enter Date/Time: 16/05/08 19:30 Sign Off:  B. Hodge

Enter Start Date/Time: 16/05/08

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
12.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT032_ASDCFTSPIR_PWR_OFF_P it will prompt: "Bus profile left as SPIRE PRIME, change manually after if required - OK to continue"		OK		1	
13.	Select OK to continue	OK	OK		1	
14.	On HPCCS stop Packet History displays for the following APIDs: 1280, 1282	OK	OK		1	
	SPIRE PRIME OFF					

Enter Date/Time: 16/05/08 19:54

Doc. No: HP-2-ASED-TP-0217  
 Issue: 1  
 Date: 08.05.08

Sign Off:  

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Enter Start Date/Time:	
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7.2.6.24 Switch ON for SPIRE REDUNDANT SMEC

The following will switch ON and configure SPIRE Redundant instrument in REDY (Standby) mode. HKTM packets will be generated on APIDs 1281 dec and 1283 decimal (these can be observed using TMPH with corresponding filter – note however a limited number of TMPHs should be running at one time).

During power on of SPIRE a number of soft/hard OOLs are reported due to the sequential switch on of the units. This is expected and will clear when SPIRE is in REDY mode. When in REDY mode one parameter remains OOL (soft) namely SMD2V505 this is also expected.

*Prs 11  
Step 4*

Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
11.	On HPCCS start Packet History displays for the following APIDs:1281,1283	OK <i>11.4</i>				
12.	From the HPCCS test conductor console start the test script to power on SPIRE Redundant: S102999SCVT033_ASDCFTSPIR_PWR_ON_R	OK		AND: ZAD07999, ZAD14999 MIM: LCL_HERSCHEL		

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
13.	<p>On HPCCS when prompted:</p> <p>"SPIRE Switch ON for Cold FT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct"</p> <p><b>Select YES</b></p>	YES				
	<p>If <b>YES</b> is selected the test script will go on to automatically power on all SPIRE warm units, force boot the DPU ASW and configure the instrument to Standby mode. Reply to prompts as indicated below.</p>	<p>AS 11.4</p>				
14.	<p>On HPCCS when prompted:</p> <p>"Check Telemetry Updating Correctly and OBT is Consistent with CDMU - OK to continue"</p> <p><b>Select OK</b></p>	OK		AND: SA_1_559		
15.	<p>If I-EGSE connected when prompted on HPCCS, perform check requested then select <b>OK</b>:</p> <p>"Check IEGSE Time Consistent - OK to continue when RAL confirm"</p>	OK				

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
16.	<p>On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue"</p> <p>Check that parameters:</p> <p>THSK Not refreshing TM2N Not incrementing Select OK to continue</p>	<p>OK 11.4</p>				
17.	<p>On HPCCS when prompted: "Check Telemetry Updating Correctly - OK to continue"</p> <p>Check that parameters:</p> <p>THSK Refreshing @ 1Hz TM2N Incrementing by 1 @ 1Hz Select OK to continue</p>	<p>OK</p>		AND: SA_1_559		

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step-No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
18.	On HPCCS when all autonomous actions have been completed by the power on script <b>S102999SCVT033_ASDCFTSPIR_PWR_ON_R</b> it will prompt: "Set Bus Profile Back to Original Setting?" Select NO At the prompt: "Bus Profile left unchanged" Select OK to continue	NO				
19.	Verify HK TM packets are being received on APIDs 1281 & 1283 <b>SPIRE DPU &amp; DRCU Redundant powered</b>	OK				

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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7.2.6.25 Procedure SPIRE-IST-COLD-FUNC-MCU-01-R

Version	2.4
Date	6th December 2007
Purpose	MCU (REDUNDANT) Boot Check
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON
Final configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	MCU voltages and board temperatures show expected 'ON' values

Enter Date/Time:		Sign Off:	
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Doc. No: HP-2-ASED-TP-0217  
 Issue: 1  
 Date: 08.05.08

Enter Start Date/Time:	
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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-01-R.tcl	—	—	—	
2	Check that the MCU is booted up successfully	MCUBITSTAT	0/1/1		
3	Check MCU HK parameter values and ensure that the values are refreshing	MCUP5V MCUP14V MCUM14V MCUP15V MCUM15V MCUMACTEMP MCUSMECTEMP MCUBSMTTEMP	~ 5.0 ± 0.2V ~ 14.0 ± 0.5V ~ -14.0 ± 0.5V ~ 15.0 ± 0.5V ~ -15.0 ± 0.5V ~300K ~300K ~300K		
<b>Test Result (Pass/Fail):</b>					

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
Doc. No: HP-2-ASED-TP-0217			
Issue: 1			
Date: 08.05.08			

Enter Start Date/Time:	
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7.2.6.26 Procedure SPIRE-IST-COLD-FUNC-MCU-03-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU Nominal Science Contents Check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	Unchanged.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK parameters show expected increment <i>1111</i>

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-03-R.tcl	MCUFRAMECNT	0/-/297		
<b>Test Result (Pass/Fail):</b>					

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Doc. No:	HP-2-ASED-TP-0217		
Issue:	1		
Date:	08.05.08		

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7.2.6.27 Procedure SPIRE-IST-COLD-FUNC-SMEC-01-R

Version	2.4
Date	6th December 2007
Purpose	SMEC (REDUNDANT) Encoder/LVDT Sensor Check.
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
Final configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
Preconditions	<ul style="list-style-type: none"> <li>SPIRE DRCU REDUNDANT is switched ON</li> <li>SPIRE MCU REDUNDANT is booted.</li> <li>SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>CCS is up and running</li> <li>FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	HK Parameters SMECECNPWR and SMECLVDTPWR show expected ON values.

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-01-R.tcl	—	—	—	
2	Check that power to the SMEC LED and LVDT sensor is on	SMECECNPWR SMECLVDTPWR	0/-/1 0/-/1		
<b>Test Result (Pass/Fail):</b>					

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Doc. No: HP-2-ASED-TP-0217  
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7.2.6.28 Procedure SPIRE-IST-COLD-FUNC-SMEC-03-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Encoder Integrity Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCUENGSMECENC SIG1/2 increase as the encoder power is increased

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-03-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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Doc. No: HP-2-ASED-TP-0217

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7.2.6.29 Procedure SPIRE-IST-COLD-FUNC-SMEC-02A-R

Version	2.4
Date	6th December 2007
Purpose	Open the SMEC Launch Latch REDUNDANT (Unlatch it)
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and SMEC is latched
Final configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and SMEC is ON and Unlatched
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	5 minutes
Pass/Fail criteria	The SMEC latch is open.

9.5

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-02A-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.30 Procedure SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-R

<b>Version</b>	1.0
<b>Date</b>	6 <sup>th</sup> December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Open Loop Feed Forward Offset Test
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
<b>Duration</b>	40 minutes
<b>Pass/Fail criteria</b>	Optimum SMEC Feed Forward Offset is determined

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
3	<p>Based on the results of this test it may be necessary to set the SMEC FF Offset manually.</p> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x9055xxxx</li> <li>param 2 = 0</li> </ul> <p>I-EGSE staff will supply the 16-bit parameter value xxxx to this command.</p>	SMECFFOFFSET	-/ - /xxxx		
4	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x9058xxxx</li> <li>param 2 = 0</li> </ul> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x905Axxxx</li> <li>param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	<p>11.4</p> <p>9 NS</p> <p>SMECENC SIG1OFF</p> <p>SMECENC SIG2OFF</p>	<p>-/ ~ Commanded Value</p> <p>-/ ~ Commanded Value</p>		

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Enter Start Date/Time: \_\_\_\_\_

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
5	Note that it may be necessary to repeat this test to fine tune the Feed Forward Offset	—	—	—	
<b>Test Result (Pass/Fail):</b>					

*11.4 SPS*

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7.2.6.31 Procedure SPIRE-IST-COLD-FUNC-SMEC-FFGAIN-R

<b>Version</b>	1.0
<b>Date</b>	6 <sup>th</sup> December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Open Loop Scan Test for different Feed Forward Gain settings
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> <li>• Test SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-R has been executed successfully</li> </ul>
<b>Duration</b>	100 minutes
<b>Pass/Fail criteria</b>	Optimum SMEC Feed Forward Gain is determined

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-FFGAIN-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
3	Based on the results of this test it may be necessary to set the SMEC FF Gain manually.  SPIRE_SEND_DRCU_COMMAND <ul style="list-style-type: none"> <li>param 1 = 0x9054xxxx</li> <li>param 2 = 0</li> </ul> I-EGSE staff will supply the 16-bit parameter value xxxx to this command.	SMECFFGAIN  R/S	U -/-/xxxx		

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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
4	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x9058xxxx</li> <li>param 2 = 0</li> </ul> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>param 1 = 0x905Axxxx</li> <li>param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	<p>SMECENC SIG10FF</p> <p>SMECENC SIG20FF</p>	<p>U -/-~ Commanded Value</p> <p>-/-~ Commanded Value</p>		
5	<p>Note that it may be necessary to repeat this test to fine tune the Feed Forward Gain</p>	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.32 Procedure SPIRE-IST-COLD-FUNC-SMEC-04A-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Open Loop Positioning Test.
<b>Initial configuration</b>	SPIRE DPU and DRUC REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRUC REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	SMEC moves to the commanded positions

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-04A-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.33 Procedure SPIRE-IST-COLD-FUNC-SMEC-09-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Open Loop Scan Test.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running.</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	SMEC performs a scan between the commanded positions

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	<p>A manual reset of the encoder signals 1 and 2 offsets may be required. If this is the case Two MANUAL commands will be required to be sent from the CCS:</p> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>• param 1 = 0x9058xxxx</li> <li>• param 2 = 0</li> </ul> <p><b>SPIRE_SEND_DRCU_COMMAND</b></p> <ul style="list-style-type: none"> <li>• param 1 = 0x905Axxxx</li> <li>• param 2 = 0</li> </ul> <p>The 16 bit parameters xxxx will be provided by I-EGSE staff</p>	<p>SMECENC SIG10FF</p> <p>SMECENC SIG20FF</p> <p style="font-size: 2em; color: gray; opacity: 0.5;">PMS</p>	<p>-/-~ Commanded Value</p> <p>-/-~ Commanded Value</p>		
2	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-09-R.tcl	—	—	—	
3	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.34 Procedure SPIRE-IST-COLD-FUNC-SMEC-07-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Close Loop Scan Test.
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	SMEC is in closed loop
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
<b>Duration</b>	10 minutes
<b>Pass/Fail criteria</b>	SMEC performs a scan between the commanded positions and the loop remains closed

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Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Before this test a SMEC calibration table on the I-EGSE may have to be changed. Please confirm with the I-EGSE staff before continuing with the next test.	—	—	—	
2	Execute TCL script SPIRE-IST-COLD-SMEC-INIT-R.tcl	SMECLOOPMODE	6/-/1		
3	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-07-R.tcl	—	—	—	
4	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.35 Procedure SPIRE-IST-COLD-FUNC-SMEC-04B-R

Version	2.4
Date	6th December 2007
Purpose	SMEC (REDUNDANT) Close Loop Positioning Test.
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON. SMEC is in closed loop.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	10 minutes
Pass/Fail criteria	SMEC moves to the commanded positions and remains in closed loop

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-04B-R.tcl	SMECLOOPMODE	1/1/1		
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.36 Procedure SPIRE-IST-COLD-FUNC-SMEC-LVDT-R

<b>Version</b>	1.0
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (REDUNDANT) Backup LVDT Close Loop Check
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON. SMEC is in closed loop.
<b>Final configuration</b>	Unchanged
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
<b>Duration</b>	90 minutes
<b>Pass/Fail criteria</b>	SMEC remains in closed loop on LVDT

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**Procedure Steps:**

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-LVDT-R.tcl	SMECLOOPMODE	1/-/4		
2	Manual commanding may be necessary during this test. Details to be specified	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.37 Procedure SPIRE-IST-COLD-FUNC-SMEC-02B-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	Close the SMEC Launch Latch (Latch it)
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and SMEC is ON and unlatched
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted and SMEC is ON and Latched
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is booted.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	The SMEC latch is closed

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-02B-R.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

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7.2.6.38 Procedure SPIRE-IST-COLD-SMEC-OFF-R

Version	2.4
Date	6th December 2007
Purpose	SMEC (REDUNDANT) Switch OFF
Initial configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are ON.
Final configuration	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted. SMEC Encoder and LVDT are OFF.
Preconditions	<ul style="list-style-type: none"> <li>SPIRE DRCU REDUNDANT is switched ON</li> <li>SPIRE MCU REDUNDANT is booted</li> <li>SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>CCS is up and running</li> <li>FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	3 minutes
Pass/Fail criteria	HK Parameters SMECENC PWR and SMECLVDTPWR show expected OFF values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-SMEC-OFF-R.tcl	—	—	—	
2	Check that the power to the SMEC sensors is switched off	SMECENC PWR SMECLVDTPWR	1/-/0 1/-/0		
<b>Test Result (Pass/Fail):</b>					

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7.2.6.39 Procedure SPIRE-IST-COLD-MCU-OFF-R

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU REDUNDANT Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU REDUNDANT are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU REDUNDANT is OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU REDUNDANT is switched ON</li> <li>• SPIRE MCU REDUNDANT is ON.</li> <li>• SPIRE MIB REDUNDANT is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK Parameter shows expected value.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-R.tcl	—	—	—	
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0		
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time: \_\_\_\_\_

7.2.6.40 Switch OFF After SPIRE REDUNDANT SMEC

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
8.	From the HPCCS test conductor console start the test script to power OFF SPIRE REDUNDANT:  S102999SCVT034_ASDCFTSPIR_PWR_OFF_R	OK				
9.	On HPCCS when prompted:  "SPIRE Switch OFF for CFT related tests in Hel/Hell conditions only - Select NO to abort TS if not correct"  <b>Select YES</b>  If <b>YES</b> is selected the test script will go on to automatically power off all SPIRE warm units.	YES	11, 14			

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_



Enter Start Date/Time: \_\_\_\_\_

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
	<p>Note: During Switch OFF of SPIRE, the following (5,1) and (5,4) event messages on APID 1281 may be expected and do not indicate a problem:</p> <p>g) EVID 1313 No_MCU_Response_Error h) EVID 21773 ALARM_LSMCU_DEAD</p> <p>However, be aware that if FDIR is enabled for SPIRE in the CDMU then this may trigger an OBCP</p>		11.4			
10.	<p>On HPCCS when prompted: "Check Telemetry No Longer Updating - OK to continue"</p> <p>Check that parameters:</p> <p>THSK Not refreshing TM2N Not incrementing</p>	<p>OK</p>		AND: SA_1_559		
11.	Select OK to continue					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: \_\_\_\_\_

Step- No.	Test-Step-Description	Nominal Value	Actual Value	Remarks	P	N
12.	On HPCCS when all autonomous actions have been completed by the power on script S102999SCVT034_ASDCFTSPIR_PWR_OFF_R it will prompt: "Bus profile left as SPIRE PRIME, change manually after if required - OK to continue"		<del>OK</del>			
13.	Select OK to continue	OK				
14.	On HPCCS stop Packet History displays for the following APIDs: 1281, 1283	OK				
	<b>SPIRE REDUNDANT OFF</b>					

Enter Date/Time: \_\_\_\_\_ Sign Off: \_\_\_\_\_

Enter Start Date/Time: 16/05/08 19:37

7.2.7 Satellite & EGSE Switch Off After SMEC Tests

Step- No.	Test-Step-Description	Nominal Value	Tolerance	Actual Value	P	N
<b>Satellite &amp; EGSE Switch Off</b>						
	Initial Conditions: Nominal & Redundant SPIRE warm units OFF					
1	On HPCSS terminate ALL_SubscribeParams.tcl test script.	OK		OK	7	
2	From HPCSS Test Conductor console issue command to disconnect from SPIRE I-EGSE			OK	7	
	disconnect HSPIREEGSE	OK		OK	7	
3	Confirm from HPCSS and SPIRE I-EGSE that the disconnection was successful	YZS29940= DISCONNECTED		DISCONNECTED	7	
4	Switch OFF I-EGSE i.a.w. AD 5	OK		N/A	7	
5	From HPCSS disable Monitoring Mode 1 (512sec cycle) for CCU A & B by executing test script:					
	K102999ECVT001_ASDGENCCU_MndBOTH1	OK		N/A	7	
6	From HPCSS power OFF CCU A & CCU B by executing test script:					
	K102999ECVT001_ASDGENCCU_ABPWROFF	OK		N/A	7	
7	Switch OFF Satellite/SVM, HPCSS and SCOE's i.a.w. procedure AD 2 Sections 7.7 to 7.11.	OK		N/A	7	
8	Confirm both Satellite and EGSE powered down	OK				
	End Conditions: Satellite and EGSE OFF					
<b>END OF SMEC TESTS</b>						

R/S  
12

Enter Date/Time: 16/05/08 19:37 Sign Off: [Signature]

Enter Start Date/Time:	
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**7.2.8 SPIRE SAFE Switch Off**

The following procedure describes the necessary steps to safely switch off SPIRE when directed by RAL personnel if an anomaly should occur.

<b>Version</b>	2.4
<b>Date</b>	6 <sup>th</sup> December 2007
<b>Purpose</b>	To switch OFF the SPIRE instrument if an anomaly should occur
<b>Initial configuration</b>	SPIRE can be in ANY configuration as specified in the test sequence in section 4.1
<b>Final configuration</b>	SPIRE is OFF
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE FM DPU is electrically integrated with the Herschel Satellite</li> <li>• SPIRE MIB is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	~5-8 minutes
<b>Pass/Fail Criteria</b>	SPIRE is OFF. All instrument subsystems are completely powered OFF.

Enter Date/Time:		Sign Off:	
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Enter Start Date/Time:	
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Step	Description	Parameter - Unit	Expected value before/after	Actual value before/after
1.	Execute Procedures: <ul style="list-style-type: none"> <li>▪ SPIRE-IST-COLD-PDET-OFF-P/R</li> <li>▪ SPIRE-IST-COLD-BSM-OFF-P/R</li> </ul>	PLIABITSAT PSWJFETSTAT PMLWJFETSTAT  CHOPSENSPWR JIGGSENSPWR	- / 0 - / 0 - / 0  - / 0 - / 0	
2.	Execute Procedures: <ul style="list-style-type: none"> <li>▪ SPIRE-IST-COLD-SDET-OFF-P/R</li> <li>▪ SPIRE-IST-COLD-SMEC-OFF-P/R</li> </ul>	SLIABITSAT SPECJFETSTAT  SMECENCPCR SMECLVDTPCR	- / 0 - / 0  - / 0 - / 0	
3.	Execute Procedures: <ul style="list-style-type: none"> <li>▪ SPIRE-IST-COLD-MCU-OFF-P/R</li> <li>▪ SPIRE-IST-COLD-SCU-OFF-P/R</li> </ul>	MCUBITSTAT  SCUTEMPSTAT SUBKSTAT	- / 0  - / 0 - / 0	


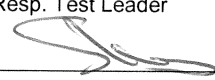

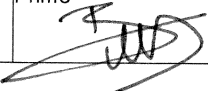

Enter Date/Time:		Sign Off:	
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8 Summary Sheets

PVS SUMMARY

- #1 - REFERS TO EMAIL 15/05/08 12:58 BY S.D. SIDHER  
ORDER OF TEST SEQ
- #2 - REFERS TO EMAIL 15/05/08 12:58 BY S.D. SIDHER  
ADDITIONAL TEST STEPS
- #3 - REFERS TO EMAIL 15/05/08 12:58 BY S.D. SIDHER.  
SECTIONS OF PROCEDURE NOT TO PERFORM
- #4 - REQUIRED S/C CONFIG FOR SMEC TESTS
- #5 - TIME SYNC BETWEEN CCS & SPIRE IEGSE
- #6 - SMEC TEMP INCREASE TOO HIGH REDUCE TEMP
- #7 - NO INDICATION OF L.L. UNLOCK
- #8 - LL. NOT UNLATCHED
- #9 - TO OBTAIN PARAMETER FOR 'FFGAIN'
- #10 - NCR 4222 (SMEC MECH FRICTION BEHAVIOUR)  
INVESTIGATION
- #11 ~~SARE\_IST\_COLD\_FUNC\_SMEC\_07\_P SCRIPT~~  
FAILS TO ACQUIRE TLM FROM IEGSE
- #12 DIFFERENT PNR OFF PROCEDURE REQUIRED  
DUE TO PREVIOUS S/C CONFIG.

	Test Change	Curr. No.: PVS#1	
		Date: 15.05.2008	
		Page: 1	of 1
Test designation	Test Procedure	Issue	Rev.
<b>SPIRE SMEC Test</b>	<b>HP-2-ASED-TP-0217</b>	<b>1</b>	
Test step changed	Reason for Change		
<b>Test Sequence of chapt. 7.2.6</b>	<b>RAL e-mail from 15.05.08, 12:58, by S.D. Sidher</b>		
<p>For tomorrow's SMEC tests I propose the following high level sequence:</p> <ol style="list-style-type: none"> <li>1) Switch on SPIRE (redundant side) - section 7.2.6.24</li> <li>2) Perform SMEC functional tests (redundant side) - sections 7.2.6.25 through 7.2.6.39</li> <li>3) Switch off SPIRE (redundant side) - section 7.2.6.40</li> <li>4) Switch on SPIRE (prime side) - section 7.2.6.1</li> <li>5) Perform SMEC functional tests (prime side) - sections 7.2.6.2 through 7.2.6.13</li> <li>6) Perform SMEC microvibration test on the prime side - sections 7.2.6.14 through 7.2.6.22</li> <li>7) Switch off SPIRE (prime side) - section 7.2.6.23</li> </ol> <p style="text-align: center;"><i>TEST SEQUENCE TO BE PERFORMED</i></p>			
Prepared by:	Resp. Test Leader	Project Engineer	
A. Koppe <i>AK</i>	<i>[Signature]</i>	N/A	
PA/QA	Prime	Customer	
<i>[Signature]</i>	<i>[Signature]</i>	<i>[Signature]</i>	

	Test Change	Curr. No.: <b>PVS#2</b>	
		Date: <b>15.05.2008</b>	
		Page: 1	of 1
Test designation	Test Procedure	Issue	Rev.
<b>SPIRE SMEC Test</b>	<b>HP-2-ASED-TP-0217</b>	<b>1</b>	
Test step changed	Reason for Change		
<b>Test Steps inserted after chapt. 7.2.6.1, 7.2.6.22, 7.2.6.24 &amp; 7.2.6.39</b>	<b>RAL e-mail from 15.05.08, 12:58, by S.D. Sidher</b>		
<p><b>SMEC functional tests (redundant side):</b>  =====</p> <p>1 - After SPIRE switch-on (section 7.2.6.24), the procedures  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-03-R according to chapter 7.2.3.3 is to be executed and  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-06-R according to chapter 7.2.3.4 is to be executed before test step 7.2.6.25</p> <p>to allow the monitoring of instrument thermometry during the tests</p> <p>2 - After MCU switch-off (see section 7.2.6.39), the procedure  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-OFF-R according to chapter 7.2.3.31 is to be executed to switch off the instrument thermometry.</p> <p><b>SMEC functional tests (prime side):</b>  =====</p> <p>3 - After SPIRE switch-on (section 7.2.6.1), the procedures  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-03-P according to chapter 7.2.2.3 is to be executed and  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-06-P according to chapter 7.2.2.4 is to be inserted before test step 7.2.6.2</p> <p>to allow the monitoring of instrument thermometry during the tests.</p> <p>4 - After MCU switch-off (section 7.2.6.22), the procedure  - <sup>FUNC</sup> SPIRE-IST-COLD-SCU-OFF-P according to chapter 7.2.2.31 is to be executed to switch off the instrument thermometry.</p>			
Prepared by:	Resp. Test Leader	Project Engineer	
A. Koppe 		M/A	
PA/QA	Prime	Customer	
			



Enter Start Date/Time: 16/05/08

7.2.2.3 Procedure SPIRE-IST-COLD-FUNC-SCU-03-P

Version	2.4
Date	6th December 2007
Purpose	SCU DC thermometry check
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and DC thermometry is ON
Constraints	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	8 minutes
Pass/Fail Criteria	SCU DC thermometry channels show temperature readings according to the actual instrument temperature

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-03-P.tcl	—	—	—	
2	Wait for the parameter BBFULLTYPE to get set to SCU_DC_Therm	—	—	—	

Enter Date/Time: 16/05/08 . 09:03 Sign Off: *[Signature]* / QA: R. Boassens *[Signature]*

PVS2 Step 3

PVS 2 Step 3

Enter Start Date/Time: 16/05/08

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
3	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0/0xFFFF/0xFFFF	0xFFFF	✓
4	If the instrument is at He I temperatures check the values of SCU DC thermometry channels.	PUMPHTRTEMP PUMPHSTEMP EVAPHSTEMP SHUNTTEMP EMCFILTEMP SLOTEMP PLOTEMP OPTTEMP BAFTEMP BSMIFTEMP SCAL2TEMP SCAL4TEMP SCALTEMP SMECIFTEMP SMECTEMP BSMTEMP	(All Values TBC) ~4.2K ~4.4K ~4.3K ~4.2K ~4.8K ~4.2K ~4.2K ~4.8K ~4.8K ~4.7K ~4.8K ~4.8K ~4.8K ~4.7K ~4.7K ~4.8K	5.24 6.75 6.62 4.57 10.20 4.81 4.88 10.25 10.75 10.34 10.31 10.16 10.22 10.05 10.09 10.22	
5	If the instrument is at He II temperatures check the values of	PUMPHTRTEMP	(All Values TBC) -1~4.6K	N/A	

Enter Date/Time: 16/05/08      09:09      Sign Off: *[Signature]* / A.A. R. Goossens

RVS2 Step 3

Enter Start Date/Time: 16/05/08

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
	SCU DC thermometry channels.	PUMPHSTEMP EVAPHSTEMP SHUNTTEMP EMCFILTEMP SLOTTEMP PLOTTEMP OPTTEMP BAFTEMP BSMIFTEMP SCAL2TEMP SCAL4TEMP SCALTEMP SMECIFTEMP SMECTEMP BSMTEMP	-/~3.0K -/~3.0K -/~1.7K -/~4.6K -/~1.7K -/~1.7K -/~4.6K -/~4.6K -/~4.5K -/~4.6K -/~4.6K -/~4.6K -/~4.6K -/~4.6K -/~4.6K -/~4.5K	N/A	
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: 16/05/08      09:09      Sign Off: *[Signature]* / R. Boossens P. BA

Enter Start Date/Time:	
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7.2.2.4 Procedure SPIRE-IST-COLD-FUNC-SCU-06-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SCU AC thermometry check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Constraints</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	2 minutes
<b>Pass/Fail Criteria</b>	SCU AC thermometry channel shows temperature readings according to the actual instrument temperature

<b>Enter Date/Time:</b>		<b>Sign Off:</b>	
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PVS2 step 3

Enter Start Date/Time: 16/05/08 09:13

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SCU-06-P.tcl	—	—	—	✓
2	Wait for the parameter BBFULLTYPE to get set to SCU_AC_Therm	—	—	—	✓
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	0/1/1	1	✓
4	If the instrument is at He I temperatures check the value of SCU AC thermometry channel.	SUBKTEMP	~4K	4.92	
5	If the instrument is at He II temperatures check the value of SCU AC thermometry channel.	SUBKTEMP	~1.7K	N/A	
6	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time: 16/05/08 09:15

Doc. No: HP-2-ASED-TP-0217  
Issue: 1  
Date: 08.05.08

Sign Off: *[Signature]* / QA: R. Baassens

Page 37

File: SPIRE FM IST Inst Comm CFT TP HP-2-ASED-TP-0217 Iss1.doc

PVS 2 - Step 3

Enter Start Date/Time: 16/05/08 19:24


7.2.2.31 Procedure SPIRE-IST-COLD-SCU-OFF-P

Version	2.4
Date	6th December 2007
Purpose	SCU PRIME Switch OFF
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON.
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is OFF
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
Duration	5 minutes
Pass/Fail criteria	Specified SCU HK Parameters show expected value.

Procedure Steps:



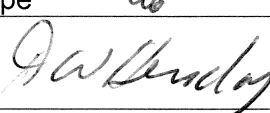
Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-SCU-OFF-P.tcl	—	—	— OK	✓
2	A few seconds later record the value of parameter SCUTEMPSTAT	SCUTEMPSTAT	0xFFFF/-0	φ	✓
3	A few seconds later record the value of parameter SUBKSTAT	SUBKSTAT	1/-0	φ	✓

Test Result (Pass/Fail):

Enter Date/Time: 16/05/08 19:24 Sign Off: 

Pvs2 step 4

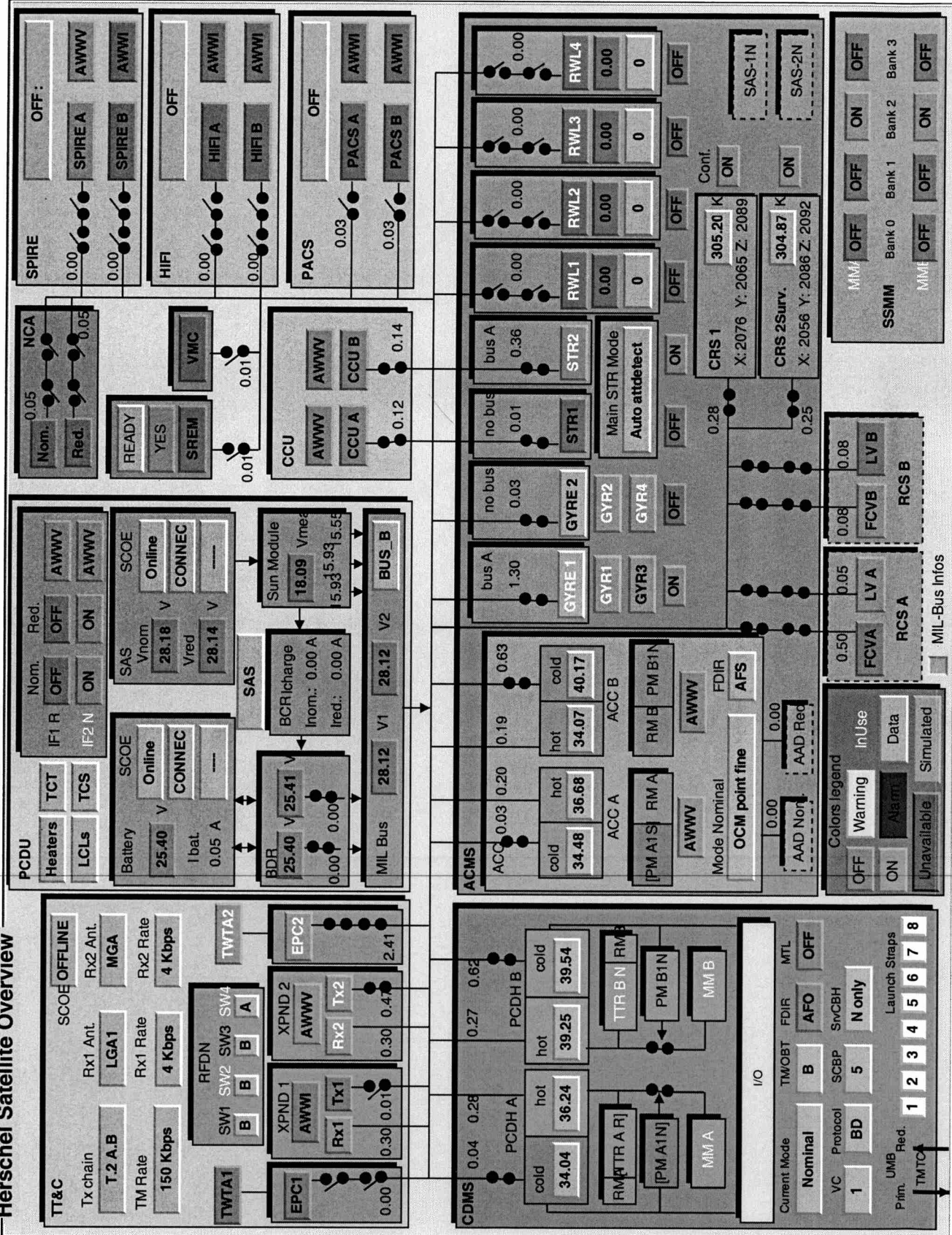
	Test Change		Curr. No.: <b>PVS#3</b>	
			Date: <b>15.05.2008</b>	
			Page: 1	of 1
Test designation	Test Procedure	Issue	Rev.	
<b>SPIRE SMEC Test</b>	<b>HP-2-ASED-TP-0217</b>	<b>1</b>		
Test step changed	Reason for Change			
<b>Test procedures 7.2.6.13 &amp; 7.2.6.36</b>	<b>RAL e-mail from 15.05.08, 12:58, by S.D. Sidher</b>			
<p><b>procedures</b></p> <p><b>SPIRE-IST-COLD-SMEC-LVDT-P (section 7.2.6.13), and</b> <i>SECTION NOT PERFORMED</i></p> <p><b>SPIRE-IST-COLD-SMEC-LVDT-R (section 7.2.6.36),</b> <i>OK</i></p> <p><b>will not be executed.</b> <i>SECTION NOT PERFORMED.</i></p>				
Prepared by:	Resp. Test Leader	Project Engineer		
A. Koppe <i>AK</i>	<i>[Signature]</i>	<i>N/A</i>		
PA/QA	Prime	Customer		
<i>[Signature]</i>	<i>[Signature]</i>	<i>[Signature]</i>		



	Test Change		Curr. No.: <b>PVS#4</b>	
			Date: <b>16.05.2008</b>	
			Page: 1	of 1
Test designation	Test Procedure	Issue	Rev.	
<b>SPIRE SMEC Test</b>	<b>HP-2-ASED-TP-0217</b>	<b>1</b>		
Test step changed	Reason for Change			
<b>Step 4 of chapt. 7.2.5</b>	<b>S/C configuration</b>			
<p><b>Configuration for the SMEC test is IST S/C Reconfiguration at start of test (see attached print out) Originally planned: CDMS PM A1 PCDU IF 1N</b></p>				
Prepared by:	Resp. Test Leader	Project Engineer		
A. Koppe 				
PA/QA 	Prime	Customer		



PVS # 4

### Herschel Satellite Overview



	Test Change		Curr. No.: PVS #5	
			Date 16.05.08	
			Page	of
Test designation	Test Procedure	Issue	Rev.	
SPIRE SMEC Test	HP-2-ASED-TP-0217	1		
Test step changed	Reason for Change			
7.2.6.1 Step 13	time sync between CCS and SPIRE IEGSE is wrong			
<ul style="list-style-type: none"> <li>- terminate SPIRE-1ST-COLD-DPU-P-SP</li> <li>- terminate S102999SCVT031-ASDCFTSPIR_PWR_ON_P</li> <li>- send cmd DC113170 to open LCL 11</li> <li>- wait 3 min</li> <li>- perform 7.2.6.1 again from step 12.</li> <li>  Step 12 OK</li> <li>  Step 13 OK, YES</li> <li>  then follow procedure again</li> </ul>				
Prepared by:	Resp. Test Leader	Project Engineer		
R. Kopp				
PA/QA	Prime	Customer		
				

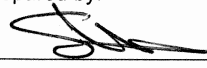


		Test Change		Curr. No.: #6	
				Date 16/05/08	
				Page 1 of 1	
Test designation		Test Procedure		Issue	
SPIRE SMEC Test		TP-0217		1	
Test step changed		Reason for Change			
Section 7.2.6.7 Step 3		SMEC starting up			
<p>1) Remove current on SMEC by sending following command:</p> <p>SCD06505, SPD4NS05 = 90558000 hex.</p> <p>Verify SMSSASIS drops to zero (0)</p> <p>2) Connect LPU Status Monitor EGSE to slc. and verify status = GREEN</p> <p>3) <sup>Send</sup> SCD06505, SPD4NS05 = 90430002 hex. to try to "re-" unlock Launch latch EGSE status = GREEN.</p>					
Prepared by:		Resp. Test Leader		Project Engineer	
PA/QA		Prime		Customer	

	Test Change	Curr. No.: #7
		Date 16/05/08
		Page 1 of 2

Test designation SPIRE SMBC Test	Test Procedure TP-0217	Issue 1	Rev. -
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Test step changed Section 7.2.6.7 Step 3	Reason for Change No indication LL unlocked
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- 0) See Page 2.
- 1) Send command DC904180 and verify that packet 120 is disabled. (TR 14, 4)
- 2) Send command 2C300999 to load new diagnostic packet
- 3) Send command DC900180 repeater 1, DH019180=26; DH020180=120
- 4) Send command ~~DC~~904180 and verify packet 120 is enabled (TR 14, 4)
- 5) Check TR per checks with ~~SPID=264000999~~ SPID=264000999 coming on CCS
- 6) Close LPU LCL25; execute DC2SD170 verify WM12B565=0N
- ~~7) Send HL command #5 (LPU enable prime), execute DCT01170, DHT01170=CMD\_ID\_HLCS~~
- 7) If ~~verify~~ WM107565=0MA which indicates ~~that LL is unlocked~~ relays are in correct position for unlatch ~~→ NRB read.~~
- 7) a) If WM107565 shows a current of ca. 130-180mA then relays are in wrong ~~conf.~~ position for unlatching LL. If so then send HLS\* and verify no change in current.
- 7) b) Send HL6 (DCT01170, DHT01170="CMD\_ID\_HL6"  
\* (DCT01170, DHT01170="CMD\_ID\_HLCS" Page 2

Prepared by: 	Resp. Test Leader 	Project Engineer
PA/QA R. Goossens 	Prime	Customer

- ✓ Verify WM107565 shows 0mA.
- ✓ 8) Assuming success in step 7 then  
of open LCL25 send command  
DC25B170 and check WM12BS65 = OFF
- ✓ 9) Switch on MCU by <sup>&SMEC</sup> executing script  
SPIRE-IST-COLD-FUNC-MCU-01-P  
SPIRE-IST-COLD-FUNC-SMEC-01-P  
SPIRE-IST-COLD-FUNC-SMEC-02A-P  
SPIRE-IST-COLD-FUNC-SMEC-OFFSET-P
- ✓ PVS6 step 3 then ~~Return to main procedure~~
- ✓ PVS6 step 1. ~~---~~

Step 0 from Page 1

- ✓ A) Switch OFF SMEC & MCU ~~execute~~  
scripts:  
SPIRE-IST-COLD-SMEC-OFF-P  
SPIRE-IST-COLD-MCU-OFF-P

RVs#7

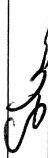
Enter Start Date/Time:	
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7.2.6.21 Procedure SPIRE-IST-COLD-SMEC-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	3 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECENCNCPWR and SMECLVDTPWR show expected OFF values.

**Procedure Steps:**

Step	Description	Parameter - Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-SMEC-OFF-P.tcl	—	—	—	
2	Check that the power to the SMEC sensors is switched off	SMECENCNCPWR SMECLVDTPWR	1/-/0 1/-/0	0 0	✓ ✓
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time:	16/05/08	11:54	Sign Off:		Page 165
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Enter Start Date/Time:	16/05/08
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7.2.6.22 Procedure SPIRE-IST-COLD-MCU-OFF-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU PRIME Switch OFF
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is OFF.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is ON.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	Specified MCU HK Parameter shows expected value.

Procedure Steps:


Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute SPIRE-IST-COLD-MCU-OFF-P.tcl	—	—	—	
2	Check that the MCU is switched off	MCUBITSTAT	1/-/0	1/0	
<b>Test Result (Pass/Fail):</b>					

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Doc. No:	HP-2-ASED-TP-0217				
Issue:	1				
Date:	08.05.08				

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7.2.6.2 Procedure SPIRE-IST-COLD-FUNC-MCU-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	MCU (PRIME) Boot Check
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	MCU voltages and board temperatures show expected 'ON' values

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Enter Start Date/Time: 16/05/08

Procedure Steps:

Step	Description	Parameter - Unit	Expected Values Before/ During/ After	Actual Values Before/ During/ After	Success/ Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-MCU-01-P.tcl	—	—	—	✓
2	Check that the MCU is booted up successfully	MCUBITSTAT	0/1/1	1	✓
3	Check MCU HK parameter values and ensure that the values are refreshing	MCUP5V MCUP14V MCUM14V MCUP15V MCUM15V	~ 5.0 ± 0.2V ~ 14.0 ± 0.5V ~ -14.0 ± 0.5V ~ 15.0 ± 0.5V ~ -15.0 ± 0.5V	5.01V 14.15V -14.47V 15.54V -15.63V	✓
		MCUMACTEMP MCUSMECTEMP MCUBSMTEMP	~300K ~300K ~300K	295.85 300.85 300.33	✓
<b>Test Result (Pass/Fail):</b>					

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Enter Start Date/Time:	16/05/08
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7.2.6.4 Procedure SPIRE-IST-COLD-FUNC-SMEC-01-P

<b>Version</b>	2.4
<b>Date</b>	6th December 2007
<b>Purpose</b>	SMEC (PRIME) Encoder/LVDT Sensor Check.
<b>Initial configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted.
<b>Final configuration</b>	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
<b>Preconditions</b>	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> </ul>
<b>Duration</b>	5 minutes
<b>Pass/Fail criteria</b>	HK Parameters SMECEENCPWR and SMECLVDTTPWR show expected ON values.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-01-P.tcl	—	—	—	✓
2	Check that power to the SMEC LED and LVDT sensor is on	SMECEENCPWR SMECLVDTTPWR	0/-/1 0/-/1	✓ ✓	✓ ✓
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time:	16/05/08	12:49	Sign Off:		Page 135
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Enter Start Date/Time:	16/05/08
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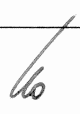

7.2.6.6 Procedure SPIRE-IST-COLD-FUNC-SMEC-02A-P

Version	2.4
Date	6th December 2007
Purpose	Open the SMEC Launch Latch Prime (Unlatch it)
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is latched
Final configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted and SMEC is ON and Unlatched
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• FUNCTIONAL TEST PARAMETERS display is selected on the CCS</li> <li>• The Herschel Cryostat should be tilted horizontal</li> </ul>
Duration	5 minutes
Pass/Fail criteria	The SMEC latch is open.

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-02A-P.tcl	—	—	—	✓
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	
<b>Test Result (Pass/Fail):</b>					

Enter Date/Time:	16/05/08	12:51	Sign Off:		Page	137
Doc. No:	HP-2-ASED-TP-0217					
Issue:	1					
Date:	08.05.08					

	Test Change	Curr. No.: # 8	Date 16/05/08
		Page 1	of
Test designation	Test Procedure	Issue	Rev.
SPIRE SMEC Test	TP-0217	1	-
Test step changed	Reason for Change		
Section 7.2.6.7 Step 3	LL not unlatched		
✓	1) Send command to "re-latch" launch lock. SCD06505, SPD4N505=9043001 hex check status of LL EGSE		
✓	2) Send comment to unlatch launch lock. SCD06505, SPD4N505=90430002 hex		
✓	3) Check on LL EGSE if light changes to red		
✓	4) Create script: SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P		
✓	5) Send SCD06505, SPD4N505=90558000 hex		
✓	6) <del>Send</del> SCD06505, SPD4N505=90557530 hex (step 3 of section 7.2.6.7)		
✓	7) Skip step 4 of section 7.2.6.7		
✓	8) Skip section 7.2.6.8		
✓	9) Section 7.2.6.11 step 1, first command sent with wrong value (0x90580000) reset with correct value (0x90589440)		
Prepared by	Resp. Test Leader	Project Engineer	
			
PA/QA	Prime	Customer	
R. Coossens 			

Enter Start Date/Time: 16/05/08

7.2.6.7 Procedure SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P




Version	1.0
Date	6 <sup>th</sup> December 2007
Purpose	SMEC (PRIME) Open Loop Feed Forward Offset Test
Initial configuration	SPIRE DPU and DRCU PRIME are ON and SPIRE HK is being produced and AC/DC thermometry is ON and MCU PRIME is booted. SMEC Encoder and LVDT are ON.
Final configuration	Unchanged
Preconditions	<ul style="list-style-type: none"> <li>• SPIRE DRCU PRIME is switched ON</li> <li>• SPIRE MCU PRIME is booted.</li> <li>• SPIRE MIB PRIME is imported in the CCS database.</li> <li>• CCS is up and running</li> <li>• SMEC PARAMETERS display is selected on the CCS</li> <li>• <b>The Herschel Cryostat should be tilted horizontal</b></li> </ul>
Duration	40 minutes
Pass/Fail criteria	Optimum SMEC Feed Forward Offset is determined

Procedure Steps:

Step	Description	Parameter – Unit	Expected Values Before/During/After	Actual Values Before/During/After	Success/Failure
1	Execute TCL script SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P.tcl	—	—	—	
2	Wait for the I-EGSE staff to confirm the success or failure of this test	—	—	—	

Enter Date/Time: 16/05/08

Sign Off:  

	Test Change	Curr. No.: #9
		Date 16/05/08
		Page 1 of 2
Test designation SPIRE SMEC Test	Test Procedure TP-0217	Issue 1
		Rev. -
Test step changed Section 7.2.6.10 Step 3	Reason for Change To obtain parameters for FFGAIN	
<p>After step 3:</p> <ol style="list-style-type: none"> <li>1) Execute script: SPIRE-IST-COLD-FUNC-SMEC-FFOFFSET-P</li> <li>2) Send command (FFOFFSET) SCD006S05, SPD4NS05 = 0x90557530</li> <li>3) Send command (FFGAIN) SCD006S05, SPD4NS05 = 0x90540DAC</li> <li>4) Repeat step 1</li> <li>5) Repeat step 2.</li> <li>6) Send command (FFGAIN) SCD006S05, SPD4NS05 = 0x9054037B</li> <li>7) Execute script SPIRE-IST-COLD-FUNC-SMEC-04A-P</li> <li>8) FFGAIN with 0x90541B87</li> <li>9) Repeat step 7.</li> <li>10) FFOFFSET = 0x90557000, FFGAIN = 0x90544E26</li> <li>11) Repeat step 7</li> <li>12) Send MCU engineering start command SCD006S05, SPD4NS05 = 0x91C10004</li> </ol>		
Prepared by: 	Resp. Test Leader 	Project Engineer
PA/QA 	Prime	Customer

✓ 13) Send commands (Encoder offsets)

SCD006505, SPD4NS05 = 0x90589A4C

SCD006505, SPD4NS05 = 0x905A7EF4

✓ 14) Execute script

SPIRE - IST - COLD - FUNC - SMEC - 09 - P

✓ 15) RAL ~~is~~ change to **CUS** database (to slow down speed.)

✓ 16) Repeat step 14.

	Test Change	Curr. No.: PVS #10 Date 16/05/08 Page 1 of 1	
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Test designation SARE SMEC Test	Test Procedure TP-0217	Issue 1	Rev. -
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Test step changed Section 7.2.6.7 Step 3	Reason for Change NCR 4222 Investigation
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1) LL EGSE removed

- 2) FF OFFSET: 0x 90559000  
 MCU Eng 0x 91210001  
 FF OFFSET = 0x 9055FFFF  
 FF OFFSET = 0x 90559000  
 Enc Offset = 0x 90589C40  
 Enc Offset = 0x 905A88B8  
 Init Enc = 0x 90490804  
 Init Enc = 0x 90490001  
 MechPosn = 0x 904512C0  
 MechPosn = 0x 90450000  
 Init Enc = 0x 90490804  
 Init Enc = 0x 90490001

All SEND\_DRCU  
 commands

3) Perform closed loop via procedure below instead of section 7.2.6.11

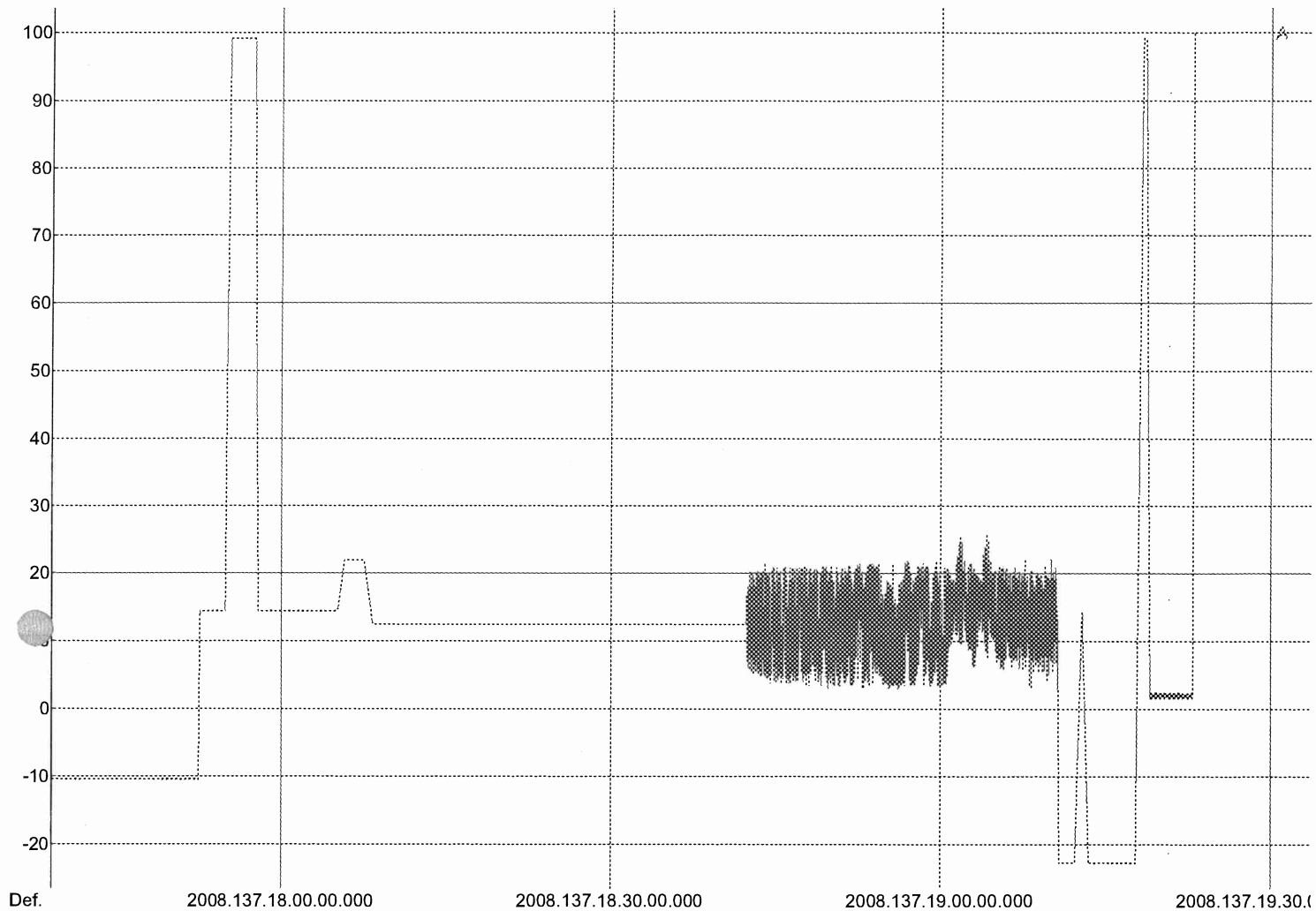
- 3.1) Init Cnds: 904C1B58  
 904B2710  
 90440001  
 904A03E8  
 904D07D0

All SEND\_DRCU  
 commands

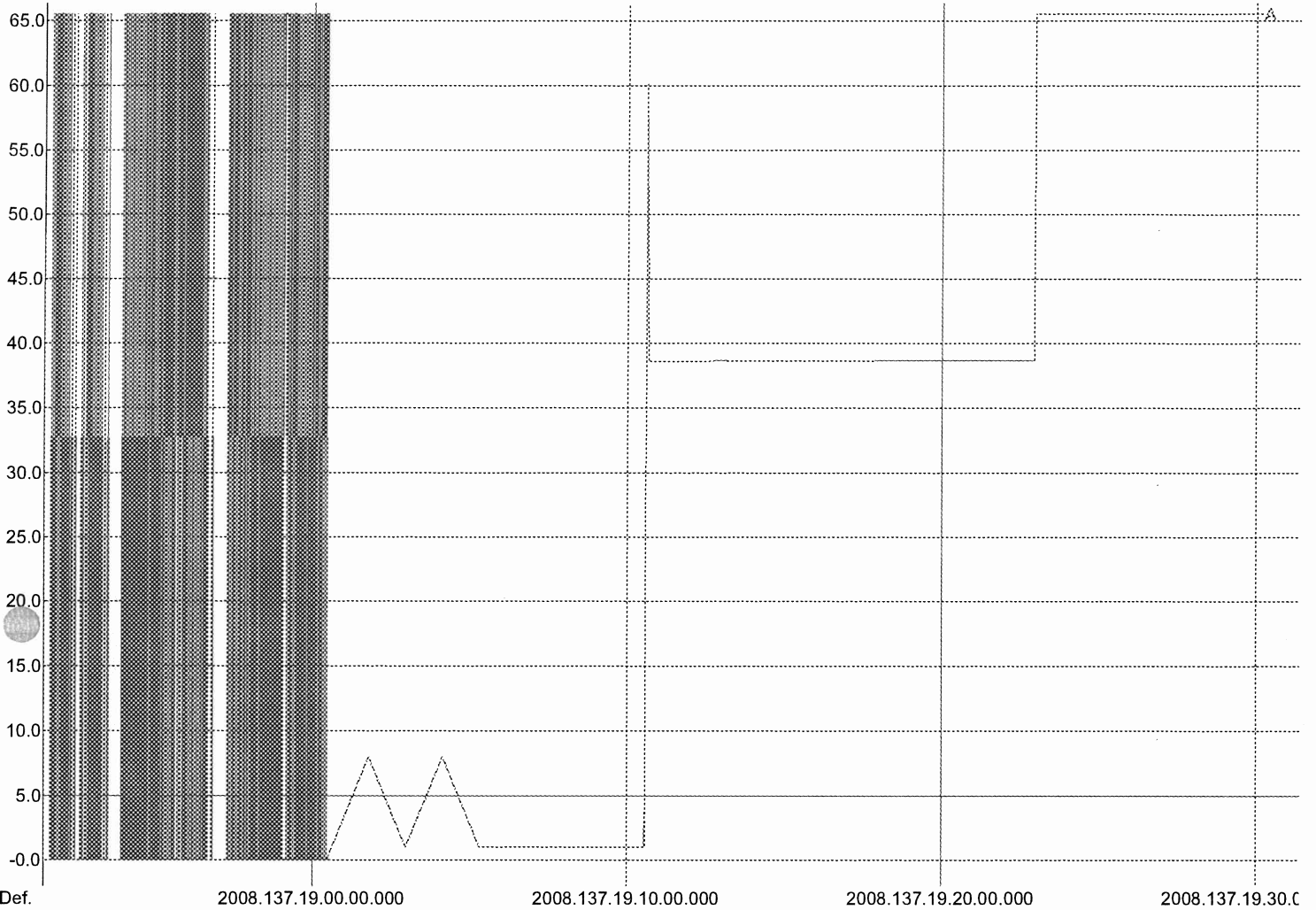
- 3.2) Execute
- a) SARE - IST - COLD - FUNC - SMEC - OFF - P (CUS updated)
  - b) SARE - IST - COLD - FUNC - SMEC - 02B - P
  - c) SARE - IST - COLD - SMEC - OFF - P
  - d) SARE - IST - COLD - MCU - OFF - P
  - e) SARE - IST - COLD - SCU - OFF - P

Prepared by: 	Resp. Test Leader 	Project Engineer
PA/QA 	Prime	Customer





Quick ID	Plotted Parameter	Value	Timestamp	Validity	Axis	Pen style
A	SMS5A515 (Eng)	12.4337	2008.137.18.13.16.314	<PAUSED>	Def.	-----



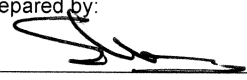


Quick ID	Plotted Parameter	Value	Timestamp	Validity	Axis	Pen style
A	SMS2P515 (Eng)	0.0010	2008.137.19.57.17.322	<PAUSED>	Def.	-----

	Test Change	Curr. No.: PVS #11
		Date 16/05/08
		Page 1 of 1

Test designation SPIRE SMEC Test	Test Procedure TP-0217	Issue 1	Rev. -
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Test step changed Section 7.2.6.7 Step 3	Reason for Change Script fails to run
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- 1) PVS #10 Step 3.2 a). script  
 SPIRE-IST-COLD-FUNC-SMEC-07-P  
 fails to obtain command parameters from  
 IEGOSE. Commands - therefore sent manually:  
 0x90451F40 } All SEND-DRCU  
 0x90480004 } commands  
 0x90490002 }  
 \$
- 2) Check launch hatch locked  
 FF0FFSETM<sub>max</sub> Curr. 0x9055FFFF } Both SEND-DRCU  
 FF0FFSETM<sub>in</sub> Curr. 0x90558000 } commands  
 RAL confirm LH Locked.
- 3) Continue procedure from section 7.2.6.23
- 4) The following procedure steps were  
 not performed  
 Sections 7.2.6.24 - 7.2.6.40. (Redundant)  
 Sections 7.2.6.14 - 7.2.6.19 (pVib)

Prepared by: 	Resp. Test Leader 	Project Engineer
PA/QA R. Goossens 	Prime	Customer


	Test Change	Curr. No.: 12	Date 16/05/08
		Page 1	of
Test designation	Test Procedure	Issue	Rev.
SP1RE S1RC Test	TP-0217	1	-
Test step changed	Reason for Change		
7.2.7 Steps 5-7	Different S1C Power OFF Req'd		
<p>As S1C powered on for S1C Reconfiguration in IST, the IST_END of this sequence is to be followed therefore skip above steps then switch OFF S1C with S1C Reconfiguration IST_END as per TP-0134.</p>			
Prepared by:	Resp. Test Leader	Project Engineer	
PA/QA	Prime	Customer	

8.2 Non Conformance Report (NCR) Summary

NCR - No.	NCR - Title	Date	Open Closed	PA sig.
NC 4221	SPIRE LAUNCH LOCK DOES NOT OPEN DURING SMEC TESTS ON NOM SIDE	16/05/08	OPEN	BDI.
NC 4222	SMEC MECHANISM FRICTION BEHAVIOUR IN START REGION	16/05/08	OPEN	BDI.
NC 4223	SPIRE SMEC LAUNCH LOCK EGSE NOT PROPERLY FUNCTIONING	16/05/08	OPEN	BDI.

Table 8.2-1: Non-Conformance Record Sheet

8.3 Sign-off Sheet

	Date	Signature
Test Director	16/05/08	
Operator	16/05/08	
PA Responsible	16/05/08	EBL.
ESA Representative		

**APPENDIX 1**

**Actual SCOE cable connection (to be confirmed by AIT)**

SCOE CABLES CONNECTION to HERSCHEL S/C					
SKIN-01	PWR Panel (PCDU)				
	Connector Function	Skin Connector	S/C unit	SCOE CABLE	Flight Connector
	BS Nom Power	SK01BJ09	PCDU	BS SCOE Cable Plugged	✓
	BS Red Power	SK01BJ10	PCDU	BS SCOE Cable Plugged	✓
	BDR1 AIT	SK01BJ11	PCDU	LPS SCOE Cable Plugged	✓
	BDR2 AIT	SK01BJ12	PCDU	LPS SCOE Cable Plugged	✓
	SA Nom Power	SK01AJ01	PCDU	POWER SCOE Cable Plugged	✓
	SA Nom Power	SK01AJ02	PCDU	POWER SCOE Cable Plugged	✓
	SA Nom Power	SK01AJ03	PCDU	POWER SCOE Cable Plugged	✓
	SA Nom Power	SK01AJ04	Battery	EMC Dust Cap	✓
	SA Red Power	SK01AJ05	PCDU	POWER SCOE Cable Plugged	✓
	SA Red Power	SK01AJ06	PCDU	POWER SCOE Cable Plugged	✓
	SA Red Power	SK01AJ07	PCDU	POWER SCOE Cable Plugged	✓
SKIN-02	PWR Panel (ACC, CDMU, RCS, 1553 & Thruster)				
	Connector Function	Skin Connector	S/C unit	SCOE CABLE	Flight Connector
	SKIN-02 DMS 1553 Bus_A	J01	CDMU	Bus Monitor Cable Plugged	✓
	SKIN-02 DMS 1553 Bus_B	J02	CDMU	Bus Monitor Cable Plugged	✓
	SKIN-02 ACMS 1553 Bus_A	J03	ACC	ACMS SCOE Cable Plugged	✓
	SKIN-02 ACMS 1553 Bus_B	J04	ACC	ACMS SCOE Cable Plugged	✓
	SKIN-02 LV1/FCV 20N CMD S/A M	J05	ACC/RCS	ACMS SCOE Cable Plugged	✓

*M. Smith*  
*16.05.08*  
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SKIN-02	LV2/FCV 20N CMD S/A R	J06	ACC/RCS	ACMS SCOE Cable Plugged	✓
SKIN-02	RCS Press/Tank Temp/PT Pwr	J07	ACC/PT&TH	ACMS SCOE Cable Plugged	✓
SKIN-02	Thruster Temp M/LV1 Sts	J08	ACC/RCS	ACMS SCOE Cable Plugged	✓
SKIN-02	CDMU and ACC EEPROM reprogramming input	J09	ACC/CDMU		Flight Plug SK02P09 Plugged ✓
SKIN-02	CDMU and ACC EEPROM reprogramming input	J10	ACC/CDMU		Flight Plug SK02P10 Plugged ✓
SKIN-02	Thruster Temp R/LV2 Sts	J11	ACC/RCS	ACMS SCOE Cable Plugged	✓
SKIN-02	Thruster C/B Heaters M	J12	ACC/CBH	ACMS SCOE Cable Plugged	✓
SKIN-02	Thruster C/B Heaters R	J13	ACC/CBH	ACMS SCOE Cable Plugged	✓
SKIN-02	Str1/2 On/Off Cmd M/Str1 Sts	J14	ACC/STR-1		ACMS Flight Plug SK02P14 Plugged ✓
SKIN-02	Str1/2 On/Off Cmd R/Str2 Sts	J15	ACC/STR-2		ACMS Flight Plug SK02P15 Plugged ✓
SKIN-02	Gyro A On/Off Cmd	J16	ACC/GYRO-E1		ACMS Flight Plug SK02P16 Plugged ✓
SKIN-02	Gyro B On/Off Cmd	J17	ACC/GYRO-E2		ACMS Flight Plug SK02P17 Plugged ✓
<b>SKIN-03</b>	TTC Panel				
	<b>Connector Function</b>	<b>Skin Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>	<b>Flight Connector</b>
SKIN-03	Test point TC + protection jumper EPC1	SK03J01	XPND1/EPC1		Plastic cap copper tape ✓
SKIN-03	Test point TC + protection jumper EPC2	SK03J02	XPND2/EPC2		Plastic cap copper tape ✓
	RF LINK				
	<b>Connector Function</b>	<b>Skin Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>	<b>Flight Connector</b>
	RF link for antenna LGA1	N/A	LGA1	RF SCOE LGA1 Plugged	LGA1 Anechoic Cap ✓
	RF link for antenna LGA2	N/A	LGA2	RF SCOE LGA2 Plugged	LGA2 Anechoic Cap ✓
	RF link for antenna MGA	N/A	MGA	RF SCOE MGA Plugged	MGA Anechoic Cap ✓
<b>SKIN-04</b>	ACMS Panel (RWE)				
	<b>Connector Function</b>	<b>Skin Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>	<b>Flight Connector</b>
SKIN-04	RWL1 Sgn	J01	ACC/RWL-1		ACMS Flight Plug SK04P01 Plugged ✓
SKIN-04	RWL2 Sgn	J02	ACC/RWL-2		ACMS Flight Plug SK04P02 Plugged ✓



SKIN-04	RWL3 Sgn	J03	ACC/RWL-3		ACMS Flight Plug SK04P03 Plugged	✓
SKIN-04	RWL4 Sgn	J04	ACC/RWL-4		ACMS Flight Plug SK04P04 Plugged	✓
<b>SKIN-05</b>	GYR/QRS Panel					
	<b>Connector Function</b>	<b>Skin Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>	<b>Flight Connector</b>	
SKIN-05	CRS1 AOCS Sgn	J01	CRS-1/ACC		ACMS Flight Plug	✓
SKIN-05	CRS2 AOCS Sgn	J02	CRS-2/ACC		ACMS Flight Plug	✓
SKIN-05	GYRO RS422 / Test	J03	GYRO	ACMS SCOE Cable Plugged		✓
SKIN-05	CRS 1/2 Stimuli	J04	CRS-1,2	ACMS SCOE Cable Plugged		✓
SKIN-05	AAD Sgn M	J05	AAD/ACC	ACMS SCOE Cable Plugged		✓
SKIN-05	SAS1/2 Sgn M	J06	SAS/ACC	ACMS SCOE Cable Plugged		✓
SKIN-05	SAS1/2 Sgn R	J07	SAS/ACC	ACMS SCOE Cable Plugged		✓
SKIN-05	AAD Sgn R	J08	AAD/ACC	ACMS SCOE Cable Plugged		✓
<b>SKIN-06</b>	STR Panel					
	<b>Connector Function</b>	<b>Skin Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>	<b>Flight Connector</b>	
SKIN-06	STR1 Stimuli	J01	STR1	ACMS SCOE Cable Plugged		✓
SKIN-06	STR2 Stimuli	J02	STR2	ACMS SCOE Cable Plugged		✓
	<b>UMBILICAL</b>					
	<b>Connector Function</b>	<b>Connector</b>	<b>S/C unit</b>	<b>SCOE CABLE</b>		
	Power/Data	HU1J01	SYSTEM	SCOE's cable Plugged		✓
	Power/Data	HU2J01	SYSTEM	SCOE's cable Plugged		✓

17.12.16 Fl. Mgr.  
16.5.08  
*[Signature]*

## APPENDIX 2

### Accelerometer Measurement & ACMS Reaction Wheel Profile for Microphonics Test

During reaction wheel activation the accelerometers on OBA and reaction wheel panel according to the Table A4-1 below shall be read. *The measurement precision, given by the type of accelerometers used, shall be in the order of a few milli-g.*

ZONE	CHANNELS ID	DESCRIPTION
OPTICAL BENCH	PACRYO201X	OBA
	PACRYO202Y	OBA
	PACRYO203Z	OBA
	PACRYO204X	OBA
	PACRYO205Z	OBA
	PACRYO206Y	OBA
-Y +Z PANEL	381X	RWL#4 to bracket I/F
	381Y	RWL#4 to bracket I/F
	381Z	RWL#4 to bracket I/F
	382X	RWL#4/RWL#2 to bracket I/F
	382Y	RWL#4/RWL#2 to bracket I/F
	382Z	RWL#4/RWL#2 to bracket I/F
	386X	RWL#3 to bracket I/F
	386Y	RWL#3 to bracket I/F
	386Z	RWL#3 to bracket I/F
	384X	RWL#1 to bracket I/F
	384Y	RWL#1 to bracket I/F
	384Z	RWL#1 to bracket I/F
	383X	RWL#2 to bracket I/F
	383Y	RWL#2 to bracket I/F
383Z	RWL#2 to bracket I/F	

**Table A4--1: Measurement Channels for Micro-vibration Test (RD8)**

It should be noted that the test configuration, as required in chapter 4.1 of RD8, can not be achieved and the test has to be performed under the conditions of this procedure.

Hmax	25	N.m.s
Tmax	0,05	N.m
Friction	0,005	N.m
DT	10	Min

time (min)	H (N.m.s)
-10	0
0	0
9,25925926	25
10	25
28,5185185	-25
30	-25
39,2592593	0
50	0

**Table A4-2: Reaction Wheel Profile**

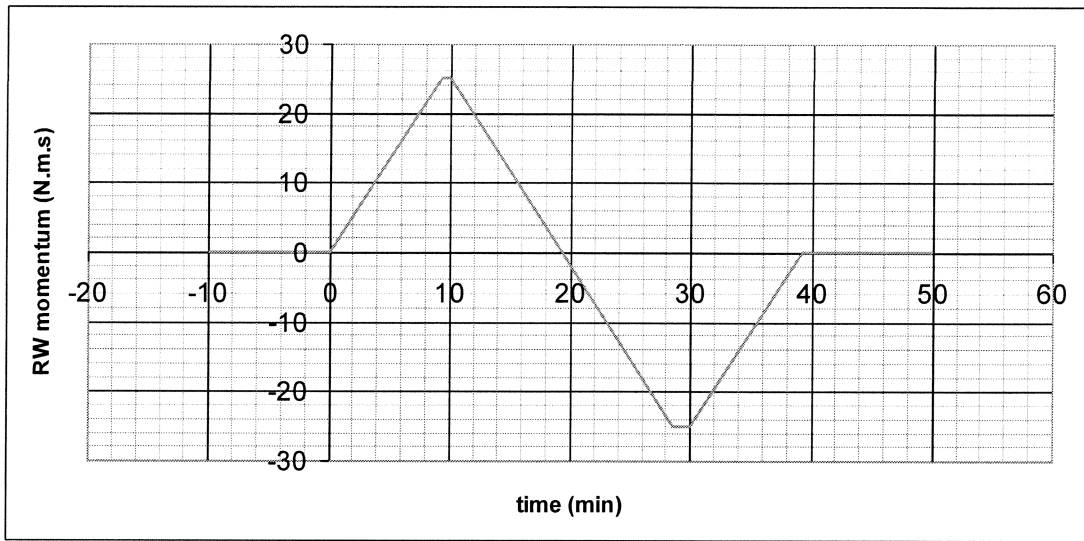


Figure A4-1: Reaction Wheel Profile Graphically

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	Name	Dep./Comp.		Name	Dep./Comp.
X	Alberti von Mathias Dr.	ASG22		Schweickert Gunn	ASG22
	Baldock Richard	FAE12	X	Sonn Nico	ASG51
	Barlage Bernhard	AED13		Steininger Eric	AED32
	Bayer Thomas	ASA42	X	Stritter Rene	AED11
	Brune Holger	ASA45		Suess Rudi	OTN/ASA44
	Edelhoff Dirk	AED2		Wagner Klaus	ASG22
	Fehringer Alexander	ASG13	X	Wietbrock Walter	AET12
X	Fricke Wolfgang Dr.	AED 65		Wöhler Hans	ASG22
	Geiger Hermann	ASA42		Wössner Ulrich	ASE252
	Grasl Andreas	OTN/ASA44	X	Theunissen Martijn/Dutch Space	ASA43
	Grasshoff Brigitte	AET12	X	Martin Olivier	ASA43
X	Hamer Simon	Terma			
X	Hendry David	Terma			
	Hengstler Reinhold	ASA42			
	Hinger Jürgen	ASG22			
X	Hohn Rüdiger	AED65			
	Hölzle Edgar Dr.	AED32			
	Huber Johann	ASA42			
	Hund Walter	ASE252			
	Idler Siegmund	AED312			
	Ivány von András	FAE12			
	Jahn Gerd Dr.	ASG22			
	Kalde Clemens	ASM2			
	Kameter Rudolf	OTN/ASA42			
	Kettner Bernhard	AET42			
	Knoblauch August	AET32	X	Alcatel Alenia Space Cannes	AAS-F
X	Koelle Markus	ASA43		Alcatel Alenia Space Torino	AAS-I
X	Koppe Axel	AED312	X	ESA/ESTEC	ESA
X	Kroeker Jürgen	AED65			
X	La Gioia Valentina	Terma		<b>Instruments:</b>	
	Lang Jürgen	ASE252		MPE (PACS)	MPE
	Langenstein Rolf	AED15	X	RAL (SPIRE)	RAL
	Langfermann Michael	ASA41		SRON (HIFI)	SRON
X	Maukisch Jan	ASA43			
X	Much Christoph	ASA43			
	Müller Jörg	ASA42		<b>Subcontractors:</b>	
X	Müller Martin	ASA43		Alcatel Alenia Space Antwerp	ABSP
	Peltz Heinz-Willi	ASG13		Austrian Aerospace	AAE
	Pietroboni Karin	AED65		Austrian Aerospace	AAEM
	Platzer Wilhelm	AED2		BOC Edwards	BOCE
	Reichle Konrad	ASA42		Dutch Space Solar Arrays	DSSA
	Runge Axel	OTN/ASA44		EADS Astrium Sub-Subsyst. & Equipment	ASSE
	Schink Dietmar	AED32		EADS CASA Espacio	CASA
	Schlosser Christian	OTN/ASA44		EADS CASA Espacio	ECAS
	Schmidt Rudolf	FAE12		European Test Services	ETS
	Schmidt Thomas	ASA42		Patria New Technologies Oy	PANT
	Schuler Günter	ASA42		SENER Ingenieria SA	SEN

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	Baldock Richard	FAE12	X	Sonn Nico	ASG51
	Barlage Bernhard	AED13		Steininger Eric	AED32
	Bayer Thomas	ASA42	X	Stritter Rene	AED11
	Brune Holger	ASA45		Suess Rudi	OTN/ASA44
	Edelhoff Dirk	AED2		Wagner Klaus	ASG22
	Fehringer Alexander	ASG13	X	Wietbrock Walter	AET12
X	Fricke Wolfgang Dr.	AED 65		Wöhler Hans	ASG22
	Geiger Hermann	ASA42		Wössner Ulrich	ASE252
	Grasl Andreas	OTN/ASA44		Martin Olivier	ASA43
	Grasshoff Brigitte	AET12		Theunissen Martijn	DutchSpace
X	Hamer Simon	Terma			
X	Hendry David	Terma			
	Hengstler Reinhold	ASA42			
	Hinger Jürgen	ASG22			
X	Hohn Rüdiger	AED65			
	Hölzle Edgar Dr.	AED32			
	Huber Johann	ASA42			
	Hund Walter	ASE252			
	Idler Siegmund	AED312			
	Ivány von András	FAE12			
	Jahn Gerd Dr.	ASG22			
	Kalde Clemens	ASM2			
	Kameter Rudolf	OTN/ASA42			
	Kettner Bernhard	AET42			
	Knoblauch August	AET32	X	Alcatel Alenia Space Cannes	AAS-F
X	Koelle Markus	ASA43		Alcatel Alenia Space Torino	AAS-I
X	Koppe Axel	AED312	X	ESA/ESTEC	ESA
X	Kroeker Jürgen	AED65			
	La Gioia Valentina	Terma		<b>Instruments:</b>	
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	Langenstein Rolf	AED15	X	RAL (SPIRE)	RAL
	Langfermann Michael	ASA41		SRON (HIFI)	SRON
	Maukisch Jan	ASA43			
X	Much Christoph	ASA43			
	Müller Jörg	ASA42		<b>Subcontractors:</b>	
X	Müller Martin	ASA43		Alcatel Alenia Space Antwerp	ABSP
	Peltz Heinz-Willi	ASG13		Austrian Aerospace	AAE
	Pietroboni Karin	AED65		Austrian Aerospace	AAEM
	Platzer Wilhelm	AED2		BOC Edwards	BOCE
	Reichle Konrad	ASA42		Dutch Space Solar Arrays	DSSA
	Runge Axel	OTN/ASA44		EADS Astrium Sub-Subsyst. & Equipment	ASSE
	Schink Dietmar	AED32		EADS CASA Espacio	CASA
	Schlosser Christian	OTN/ASA44		EADS CASA Espacio	ECAS
	Schmidt Rudolf	FAE12		European Test Services	ETS
	Schmidt Thomas	ASA42		Patria New Technologies Oy	PANT
	Schuler Günter	ASA42		SENER Ingenieria SA	SEN